

OPTICAL SIGNAL QUALITY MONITORING CIRCUIT AND OPTICAL
SIGNAL QUALITY MONITORING METHOD

Inventors: Hidehiko Takara et al.

Docket No. 14321.87

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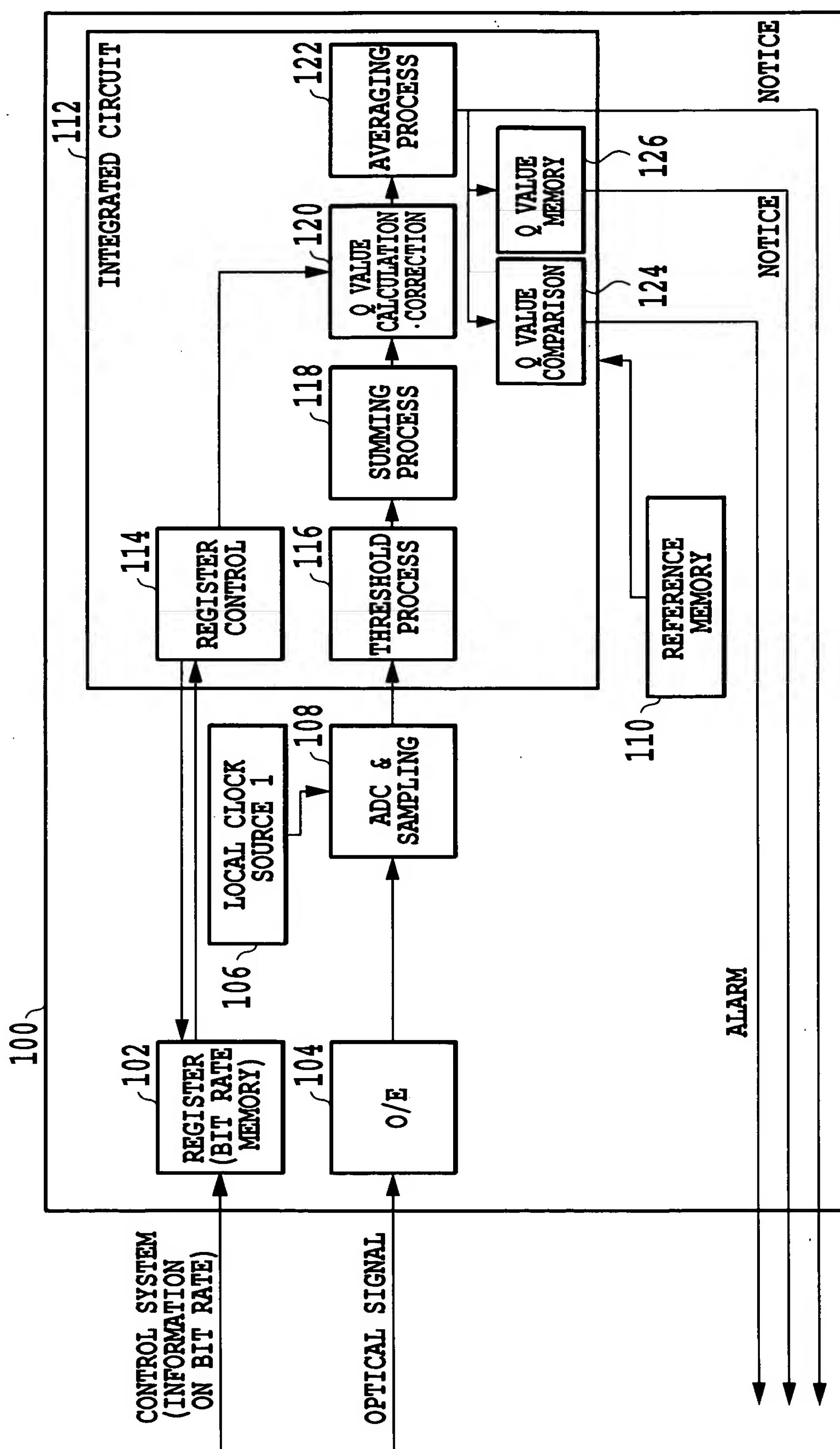


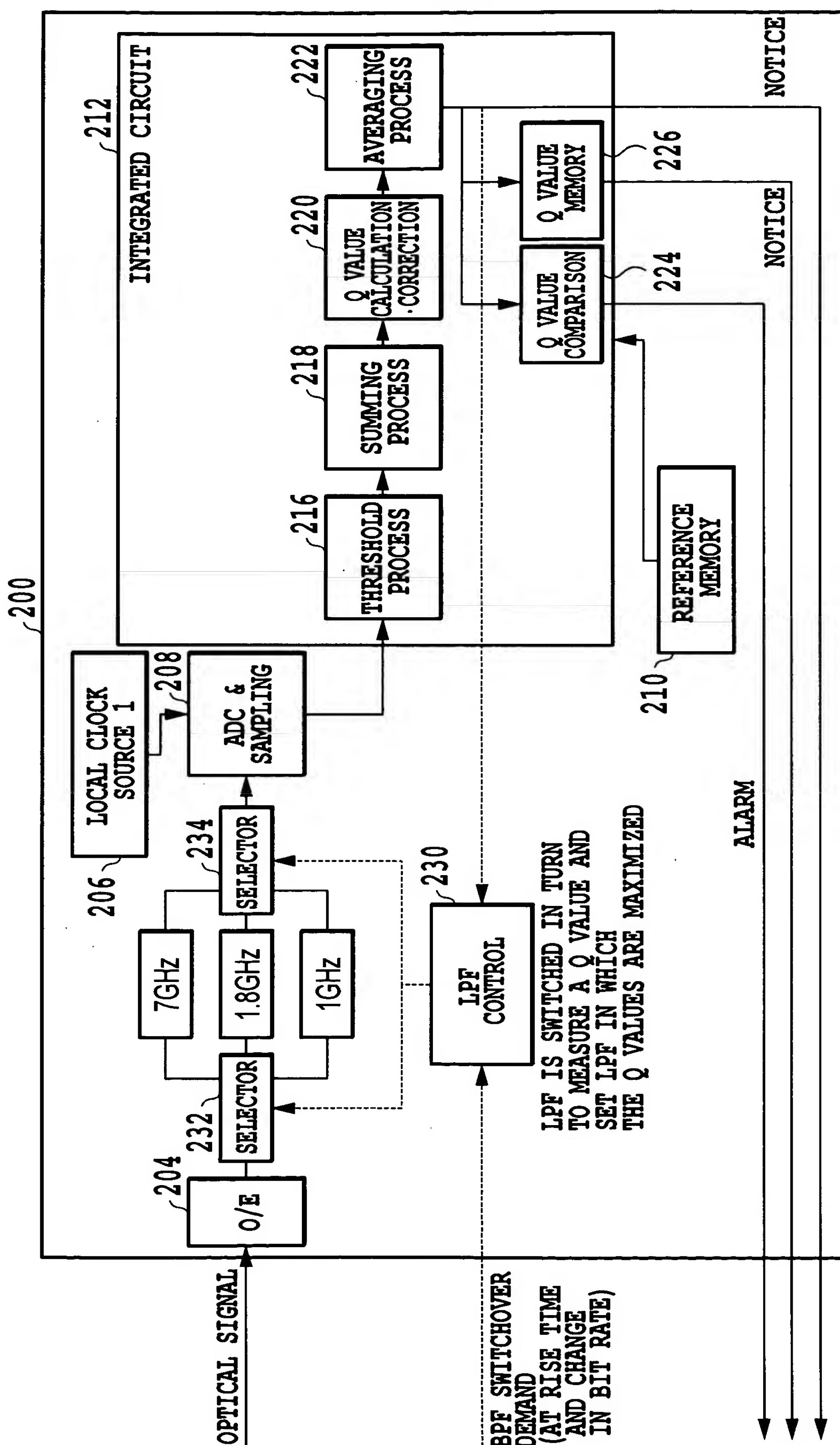
FIG. 1

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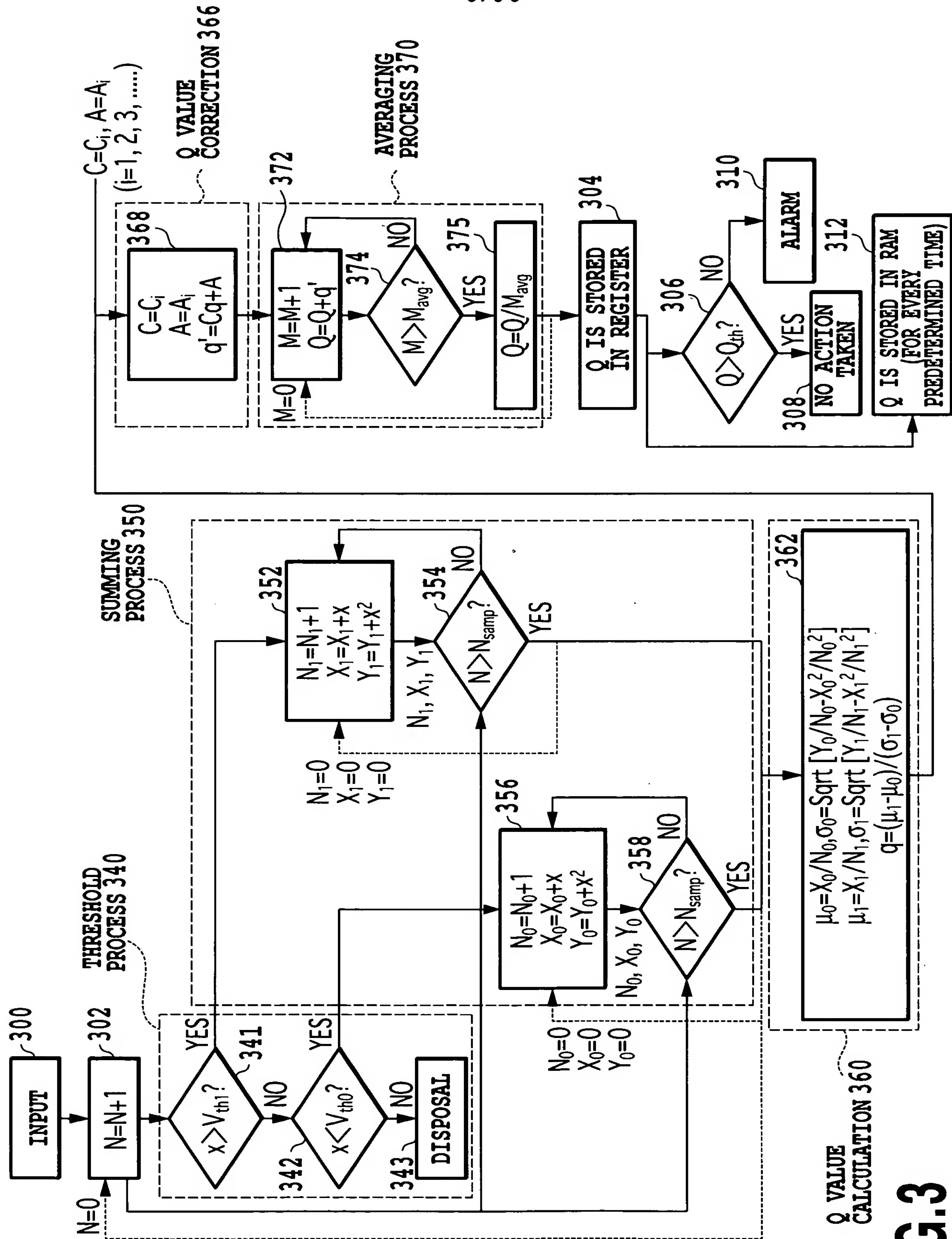


FIG.3

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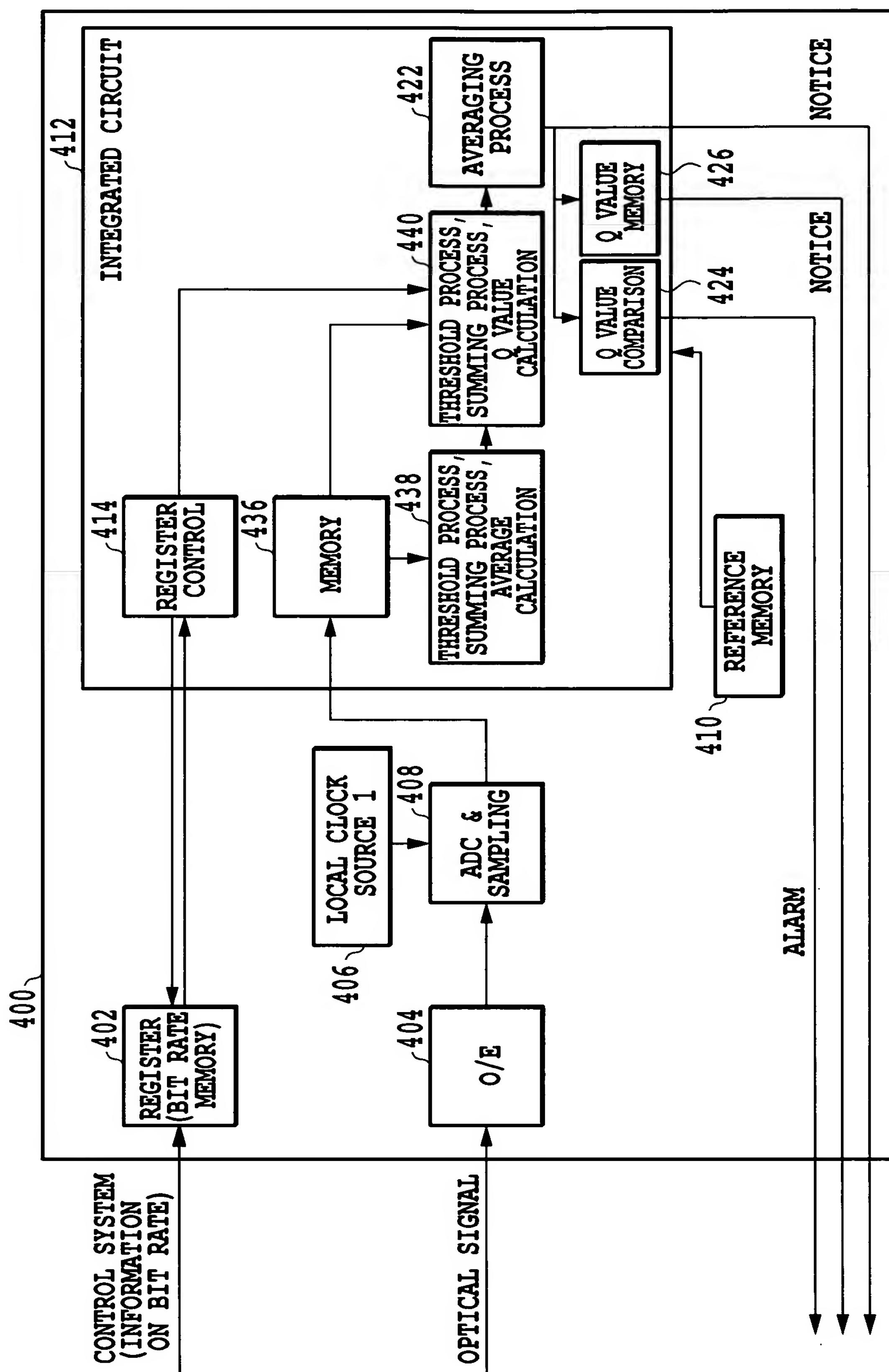


FIG.4

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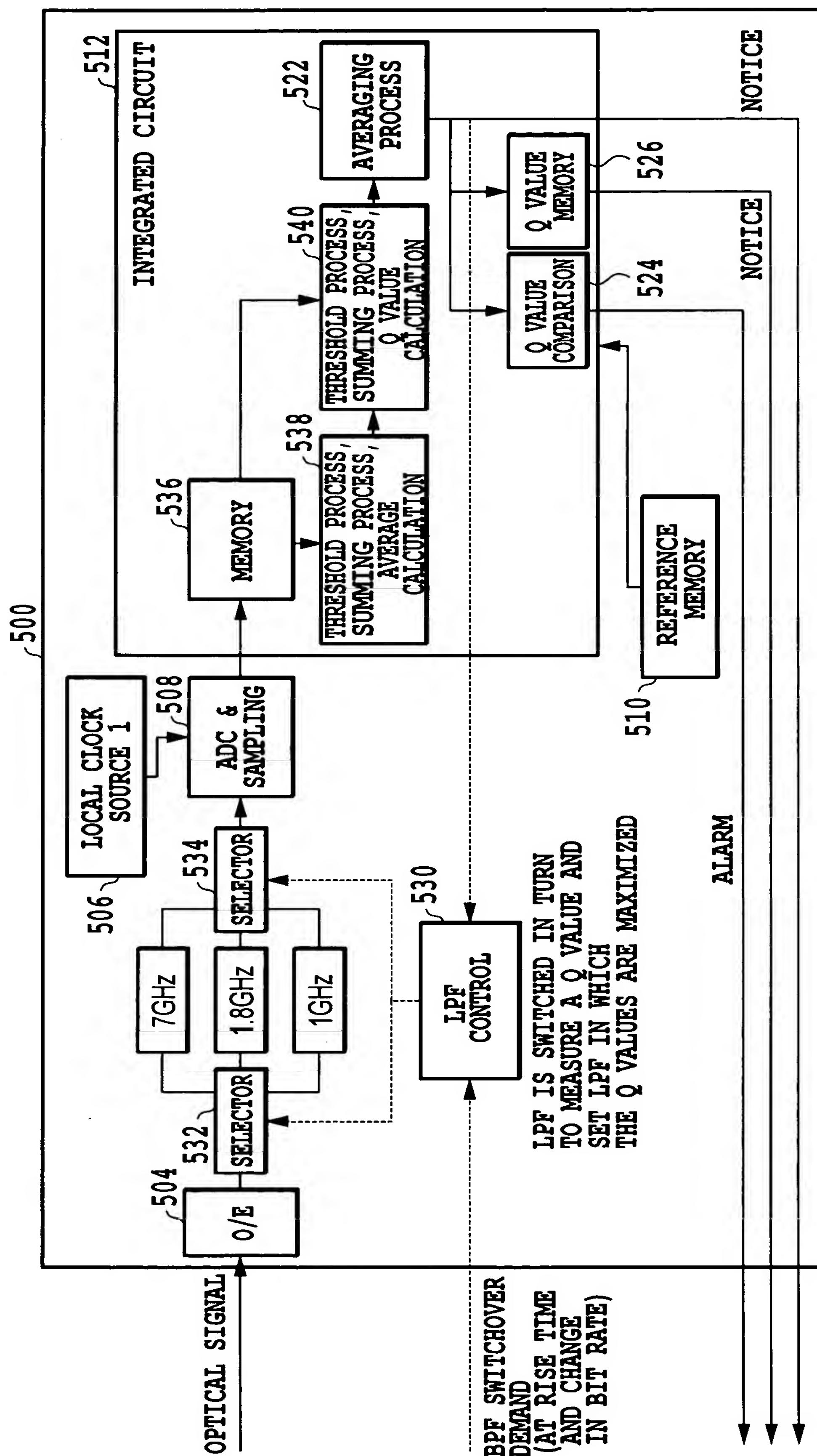


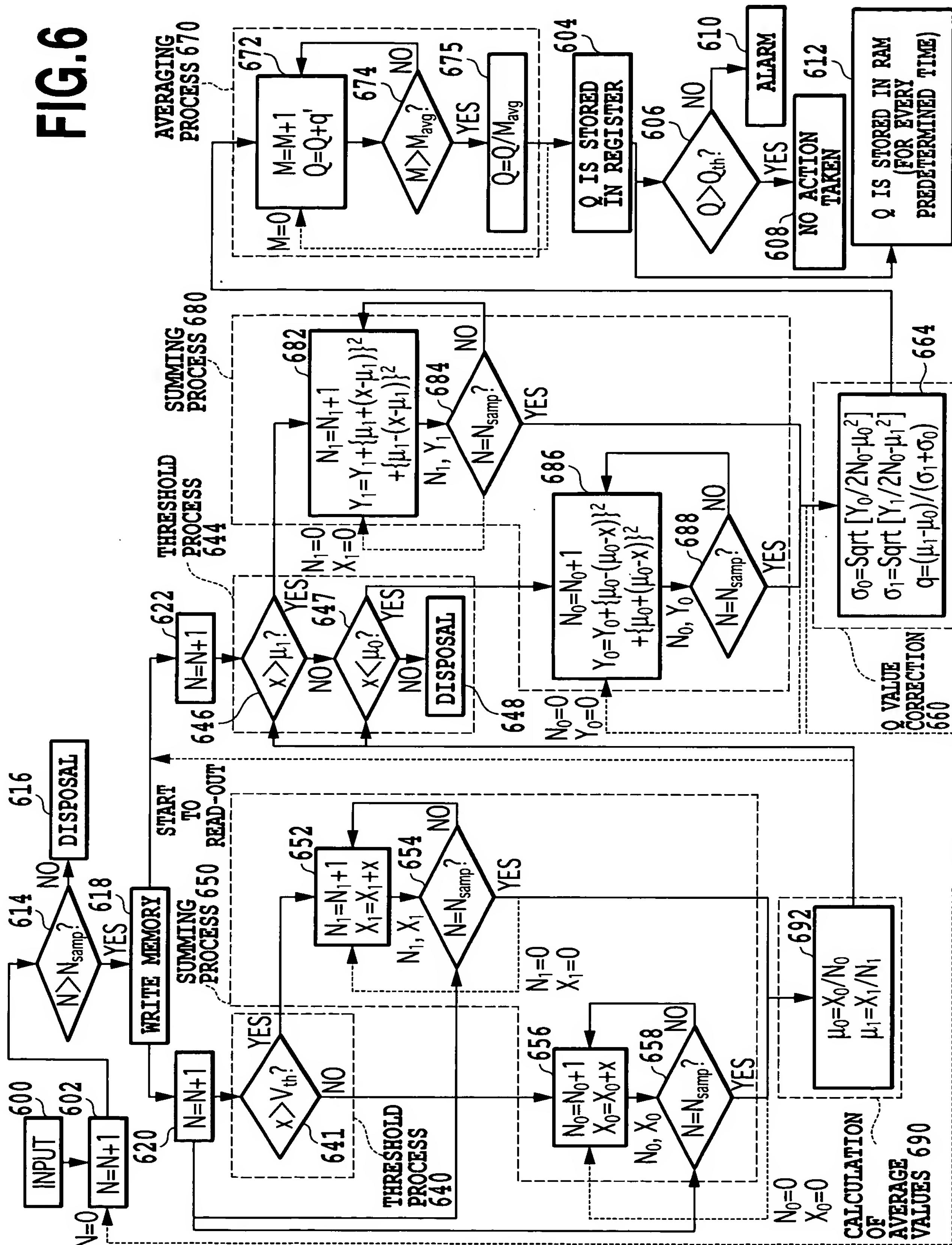
FIG.5

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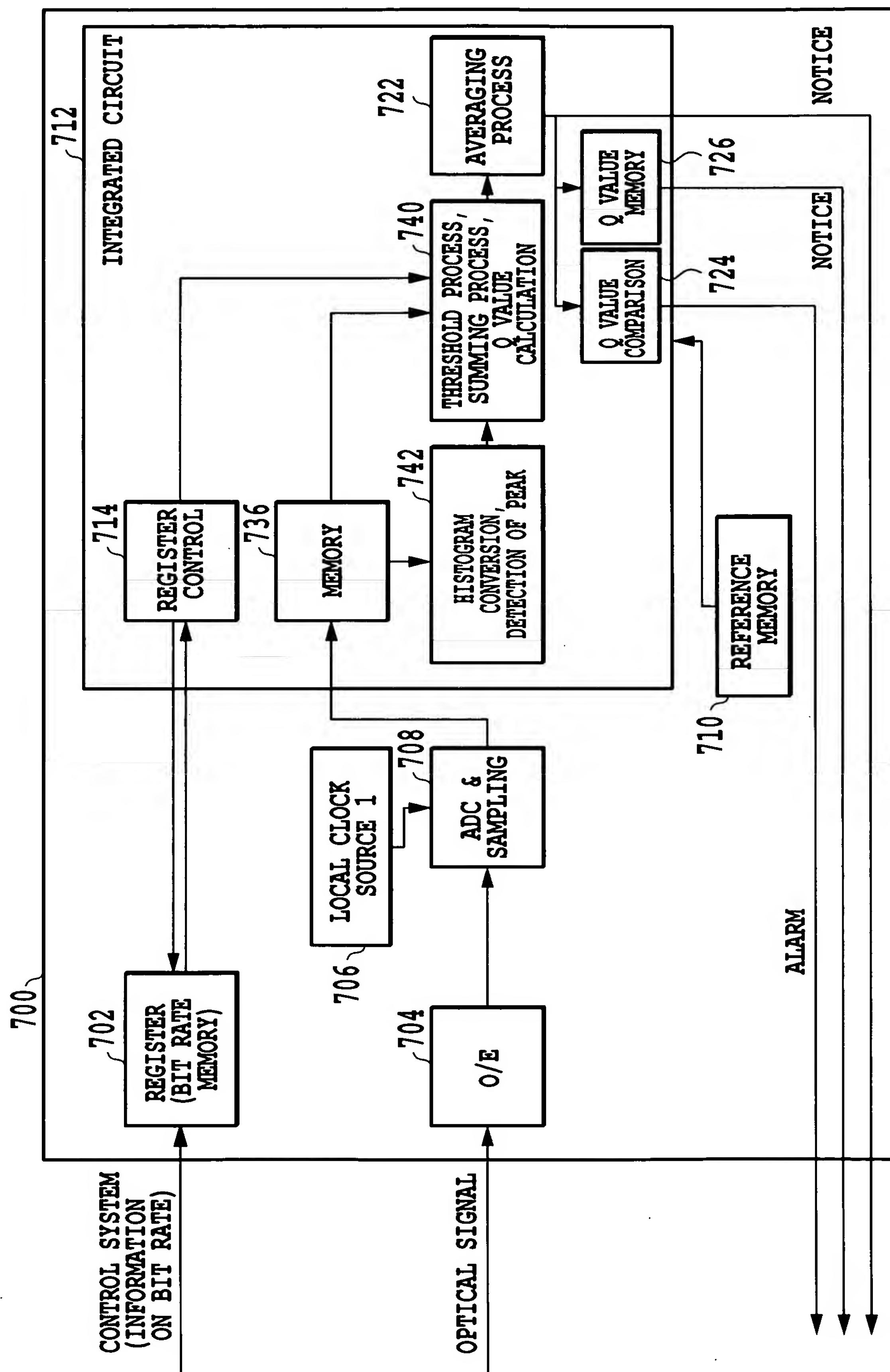


FIG. 7

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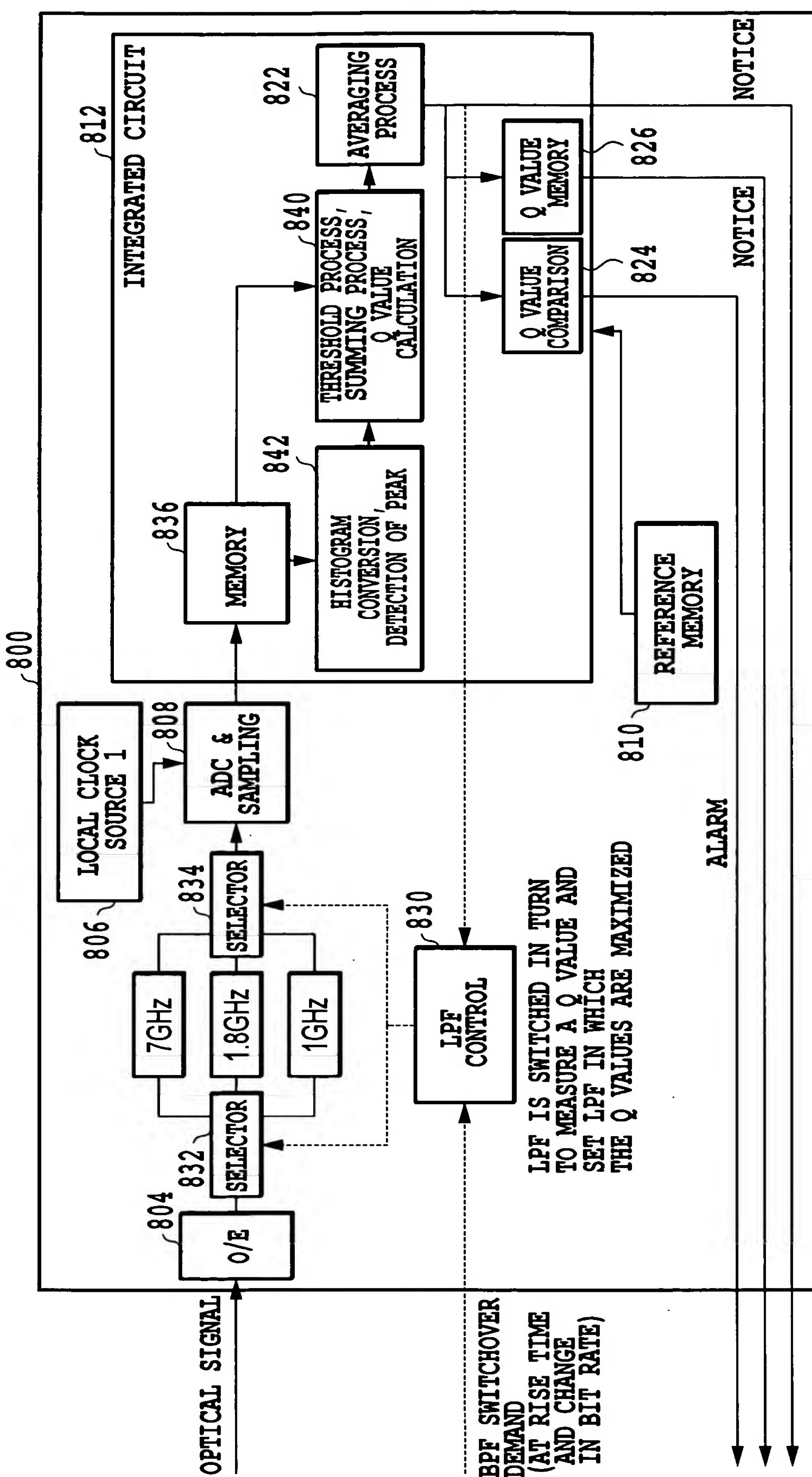


FIG.8

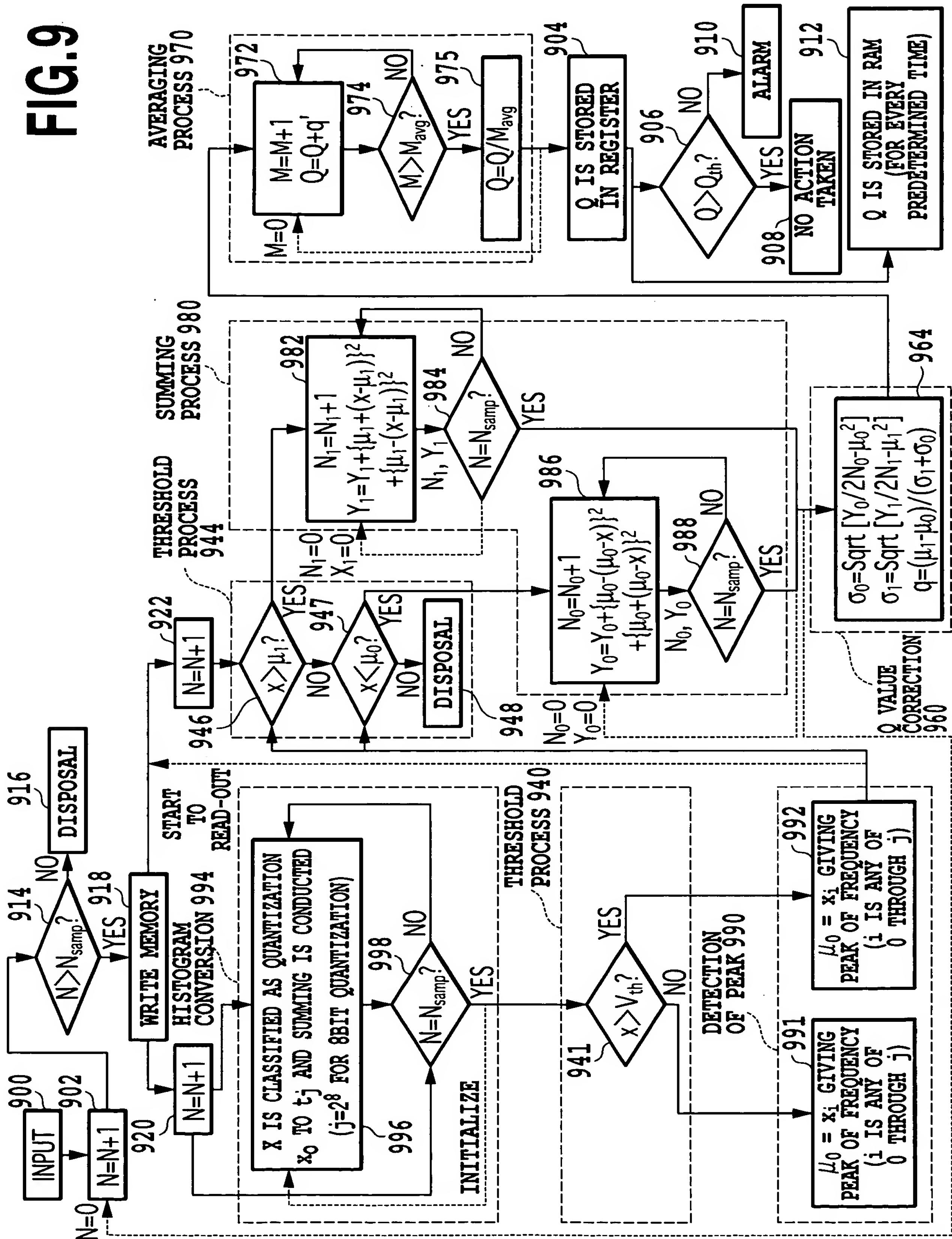
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FIG.9



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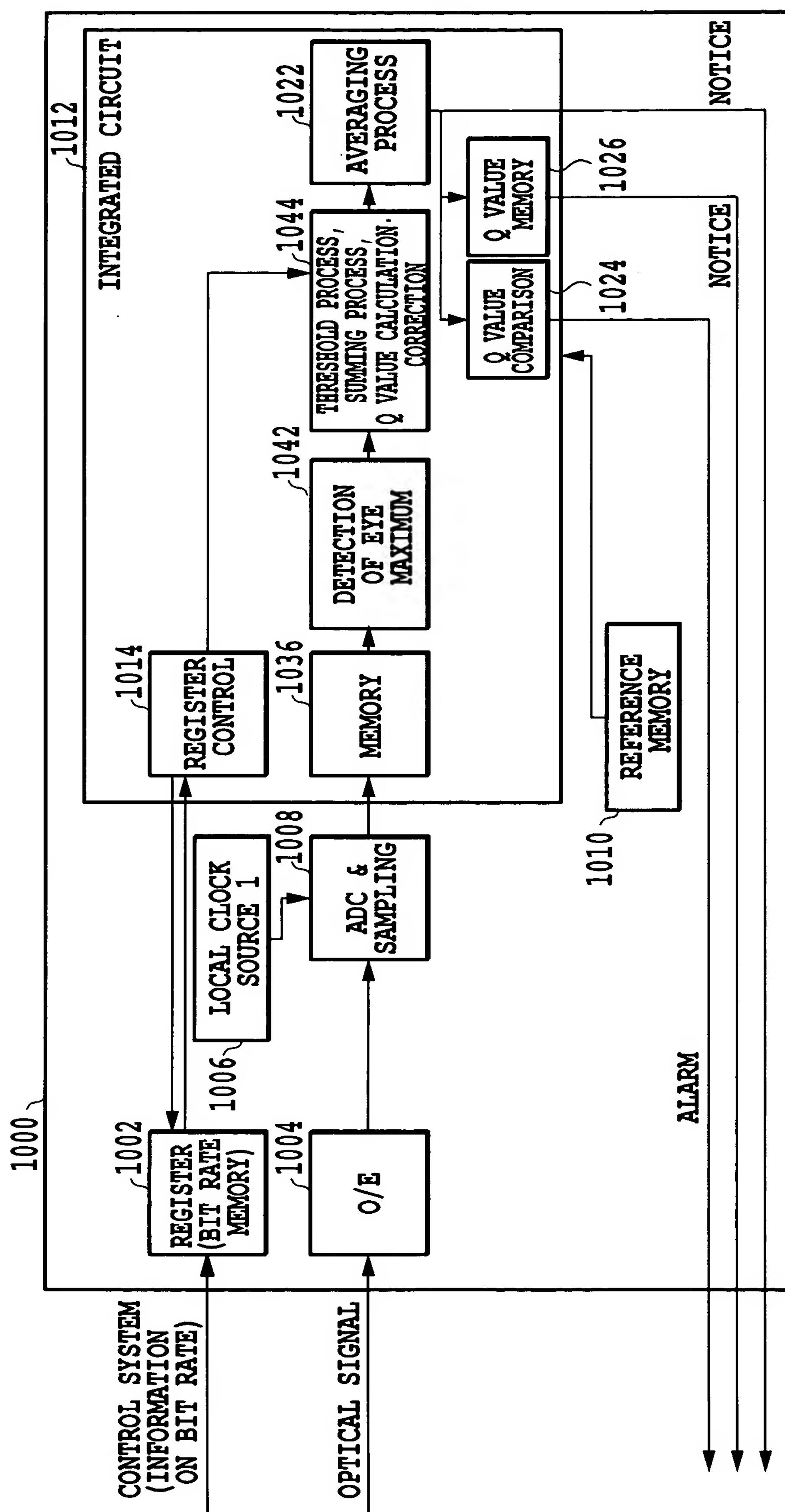


FIG. 10

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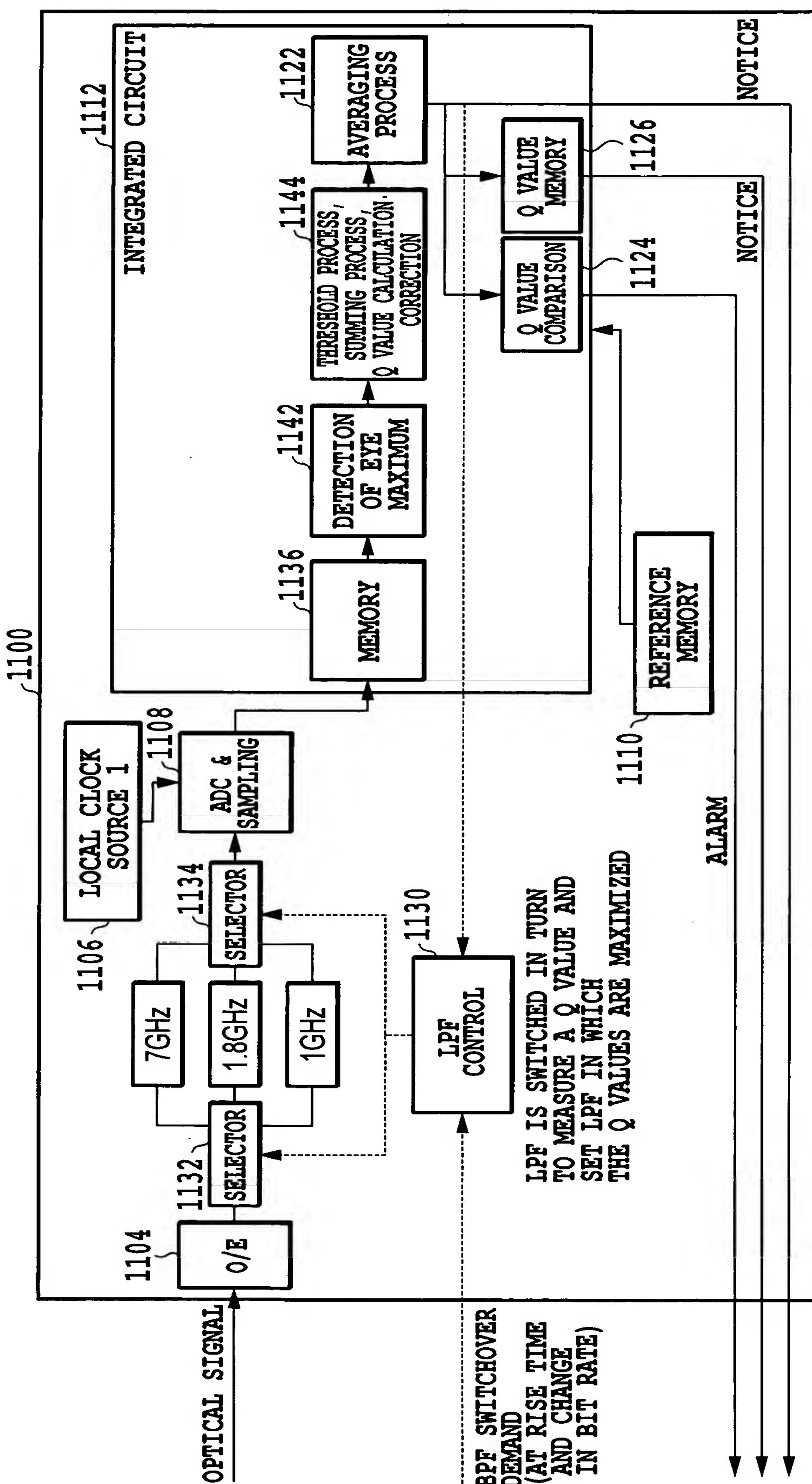


FIG.

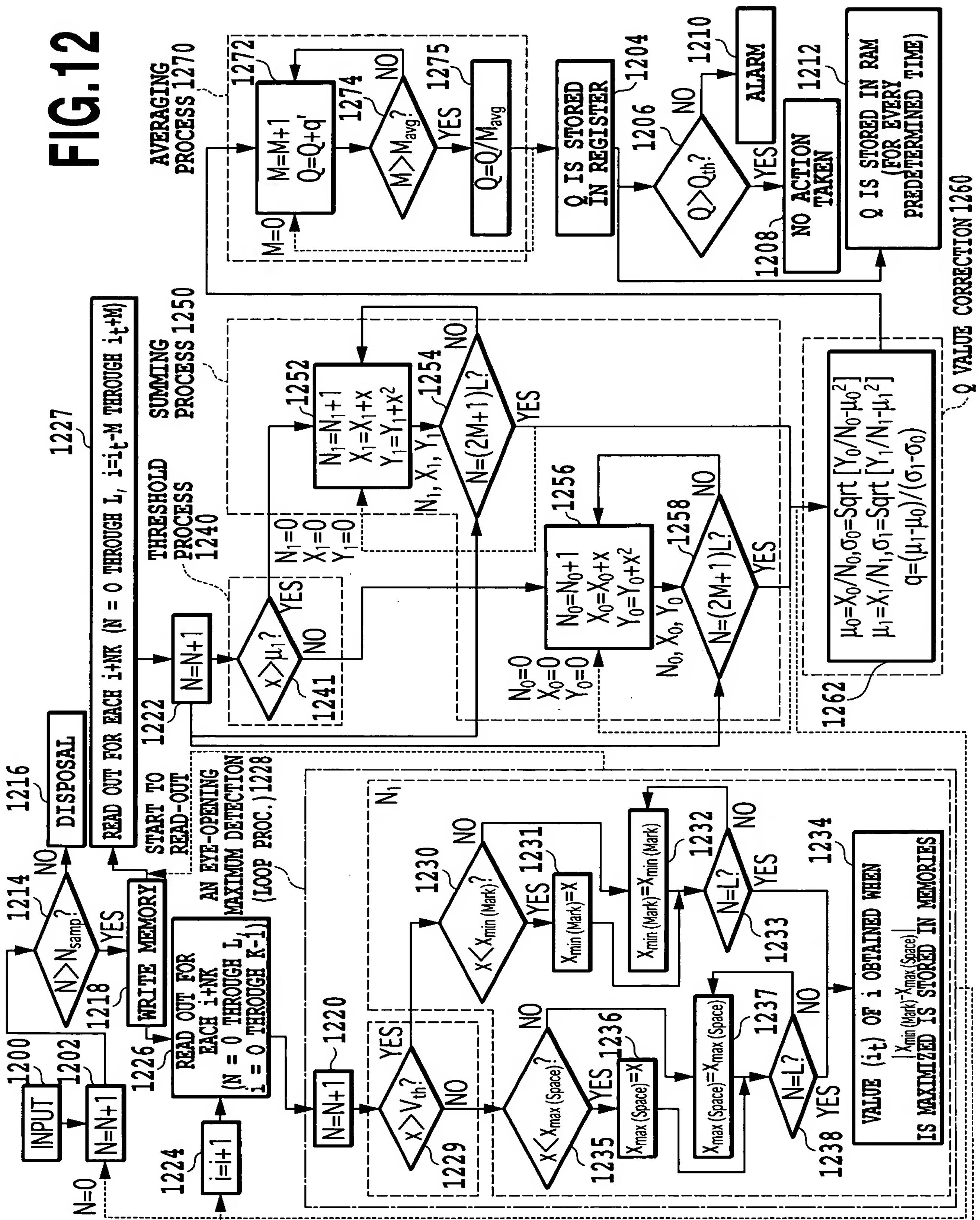
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FIG. 12



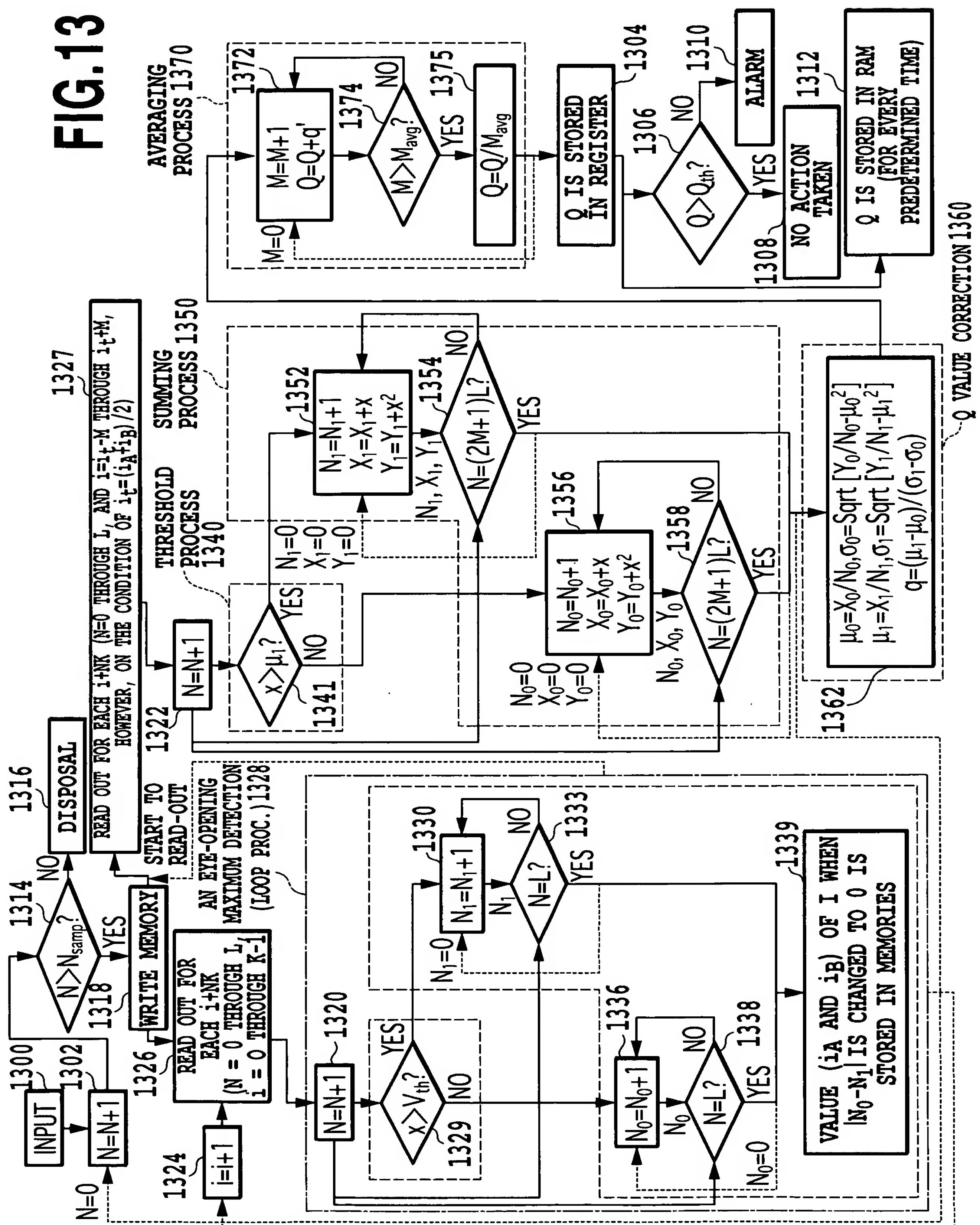
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FIG. 13



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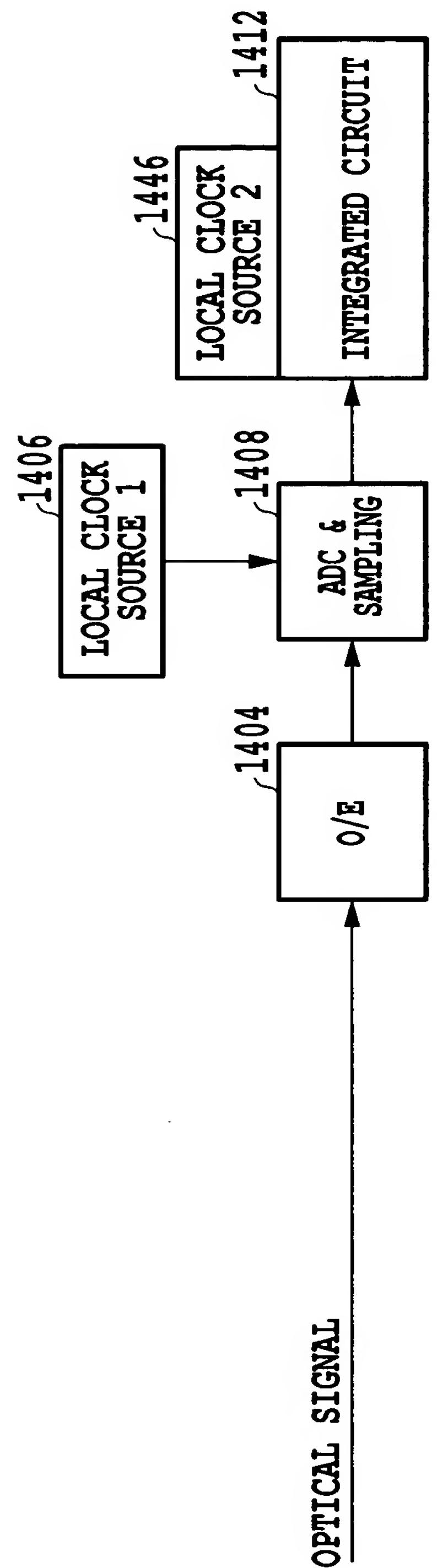


FIG. 14

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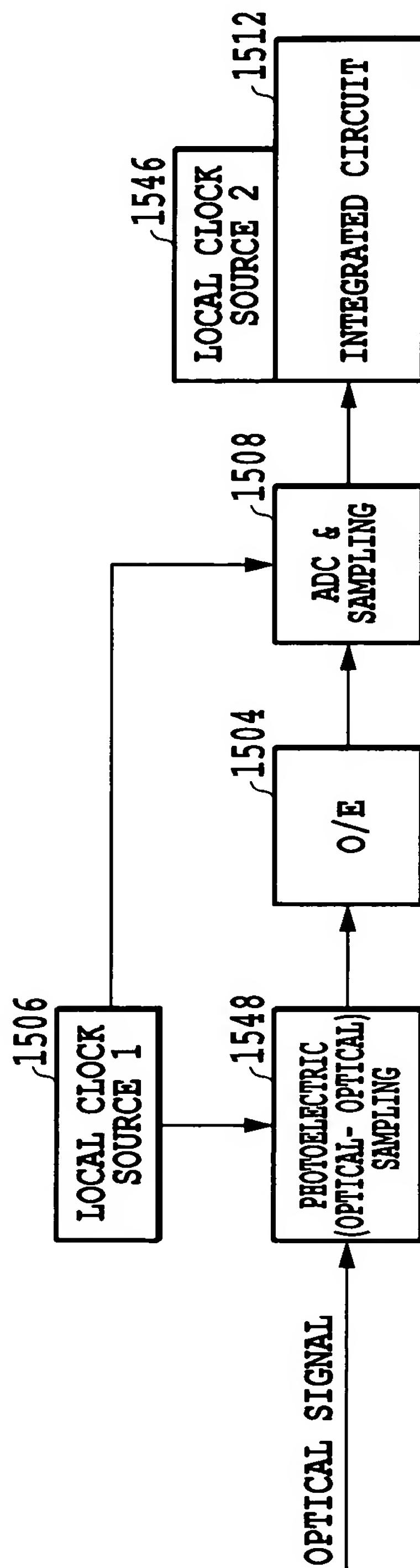


FIG. 15

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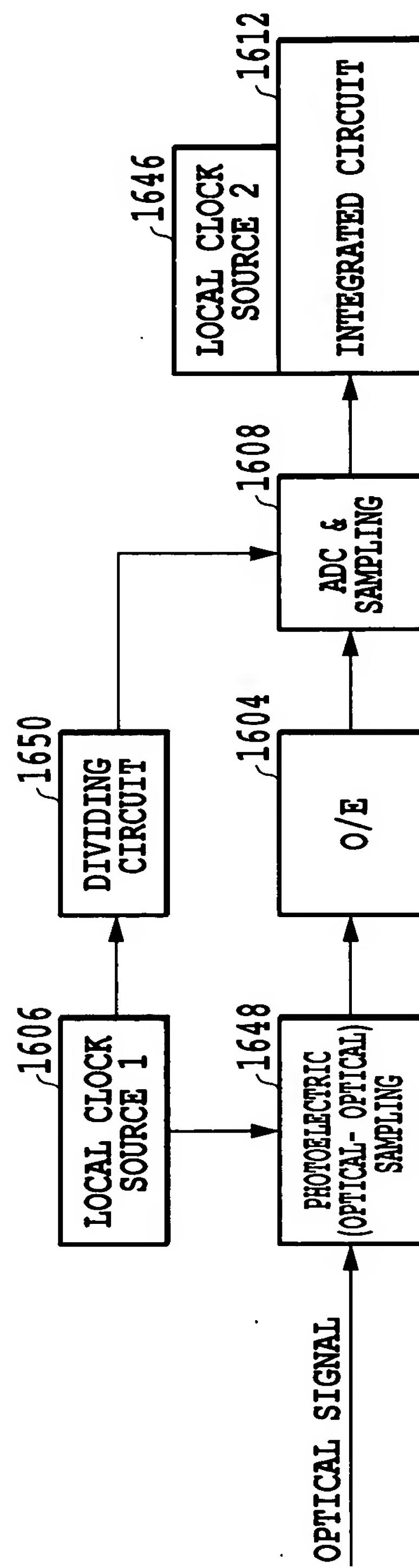


FIG. 16

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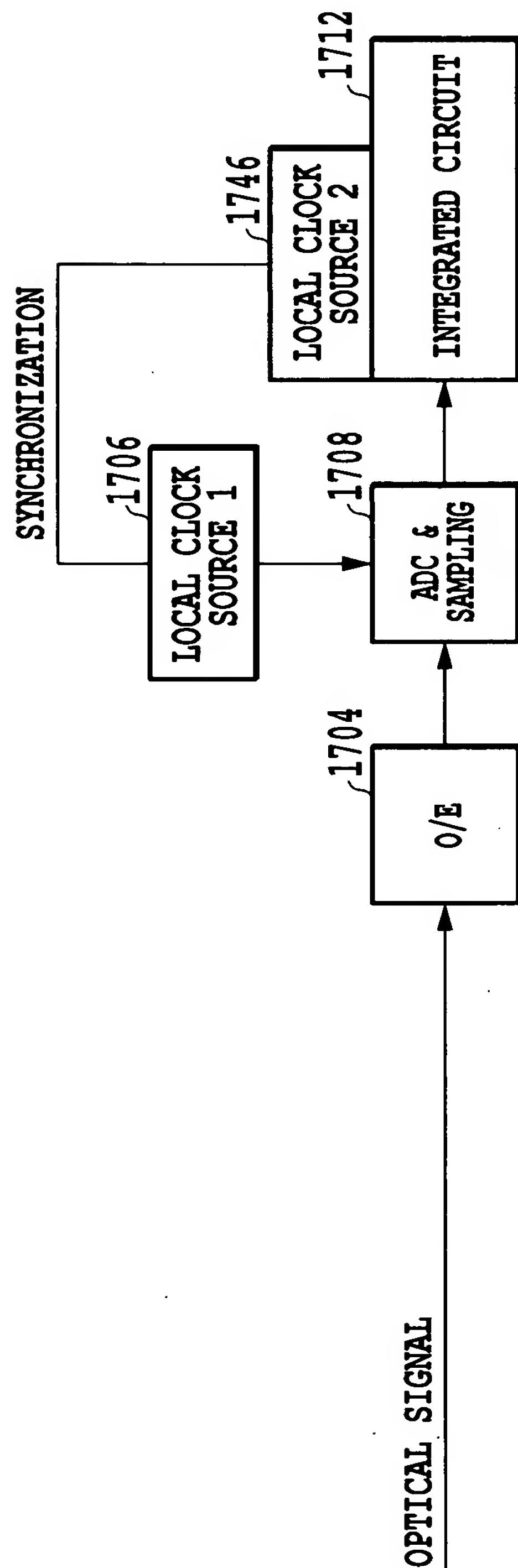


FIG. 17

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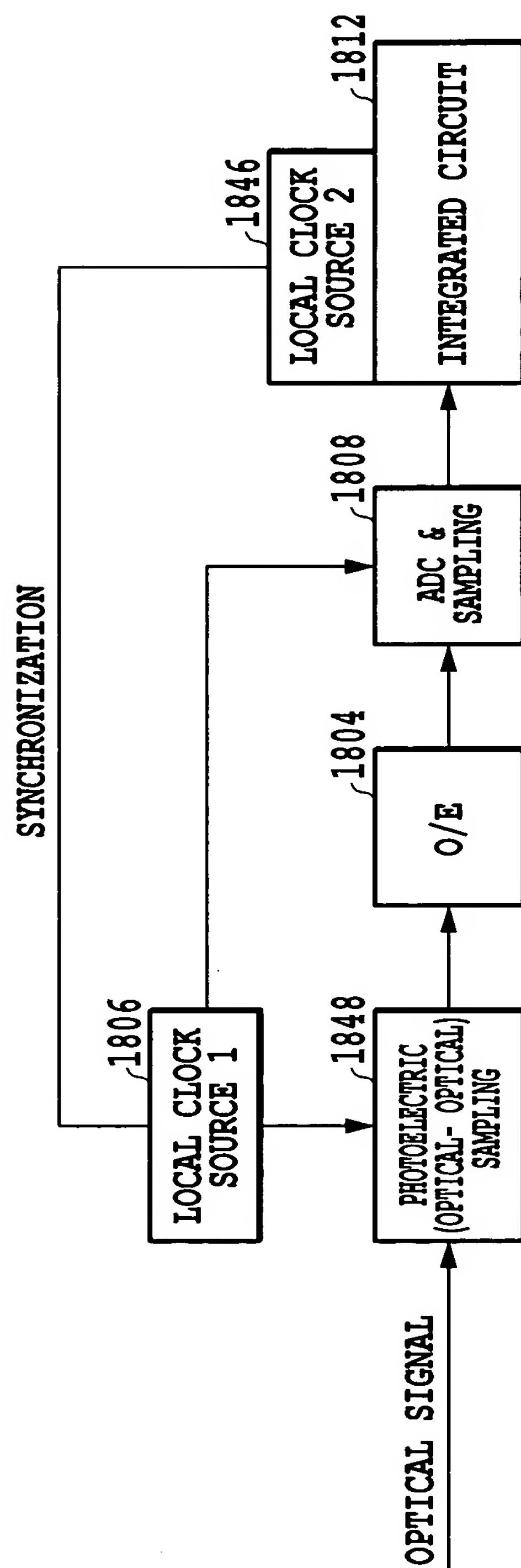


FIG. 18

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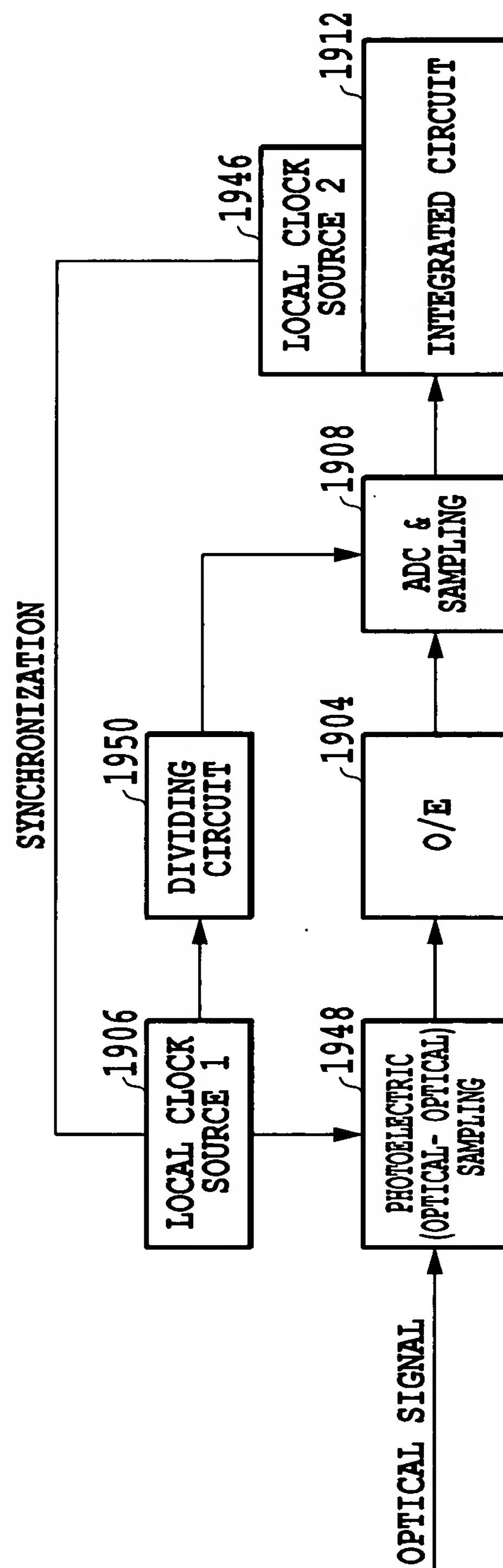


FIG. 19

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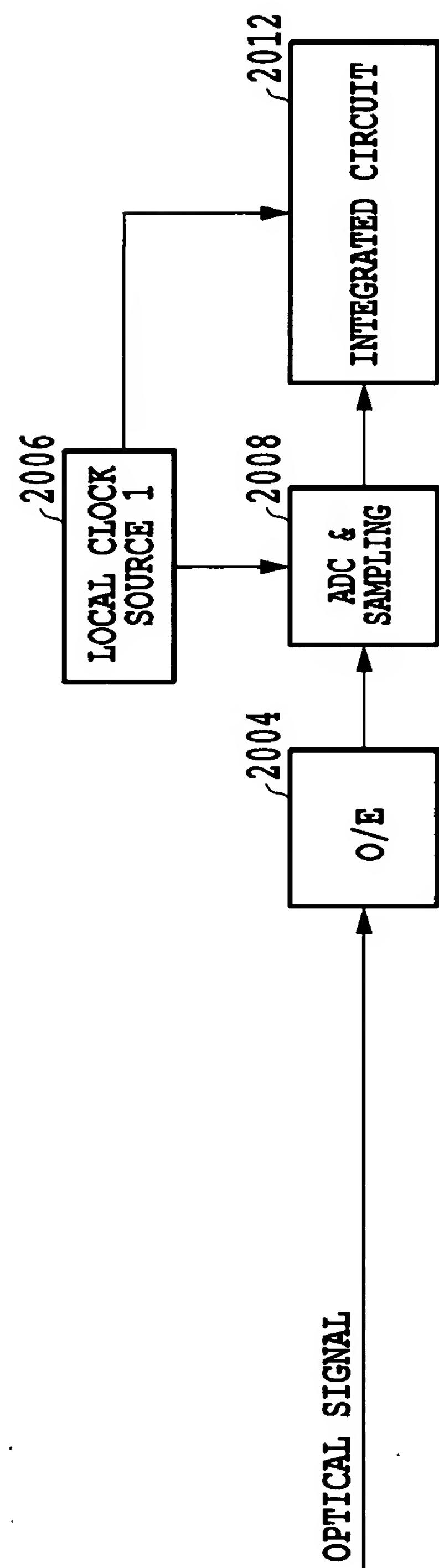


FIG.20

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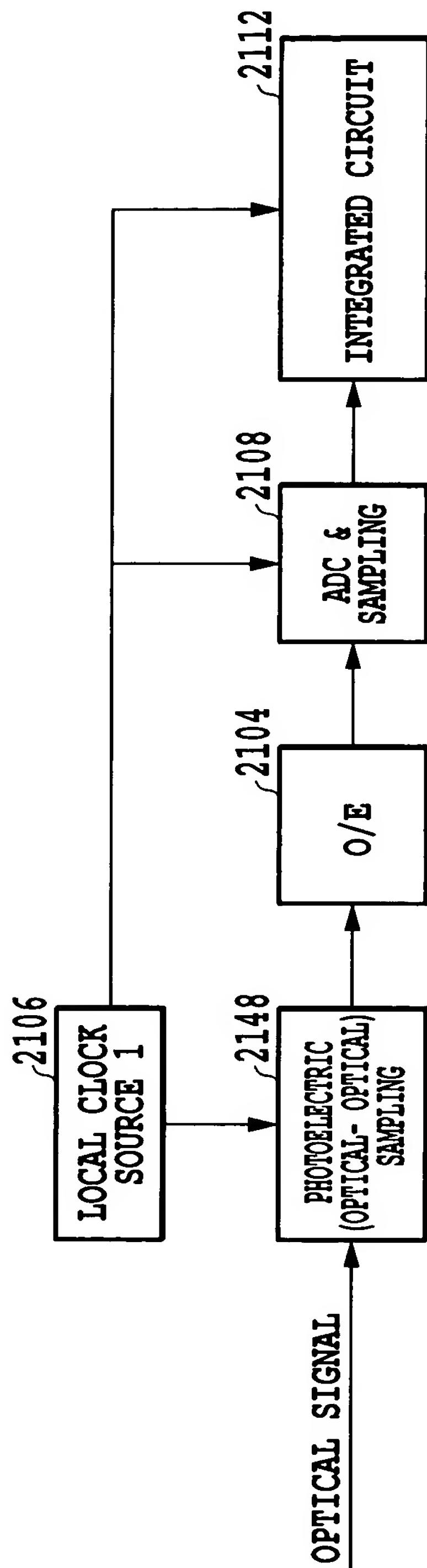


FIG.21

OPTICAL SIGNAL QUALITY MONITORING CIRCUIT AND OPTICAL
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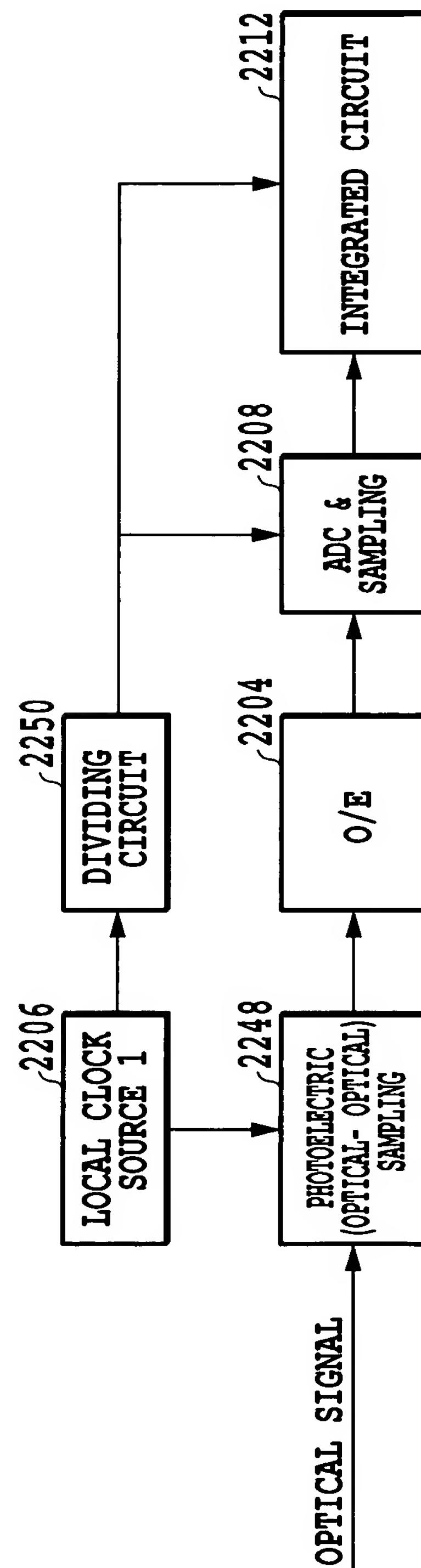


FIG.22

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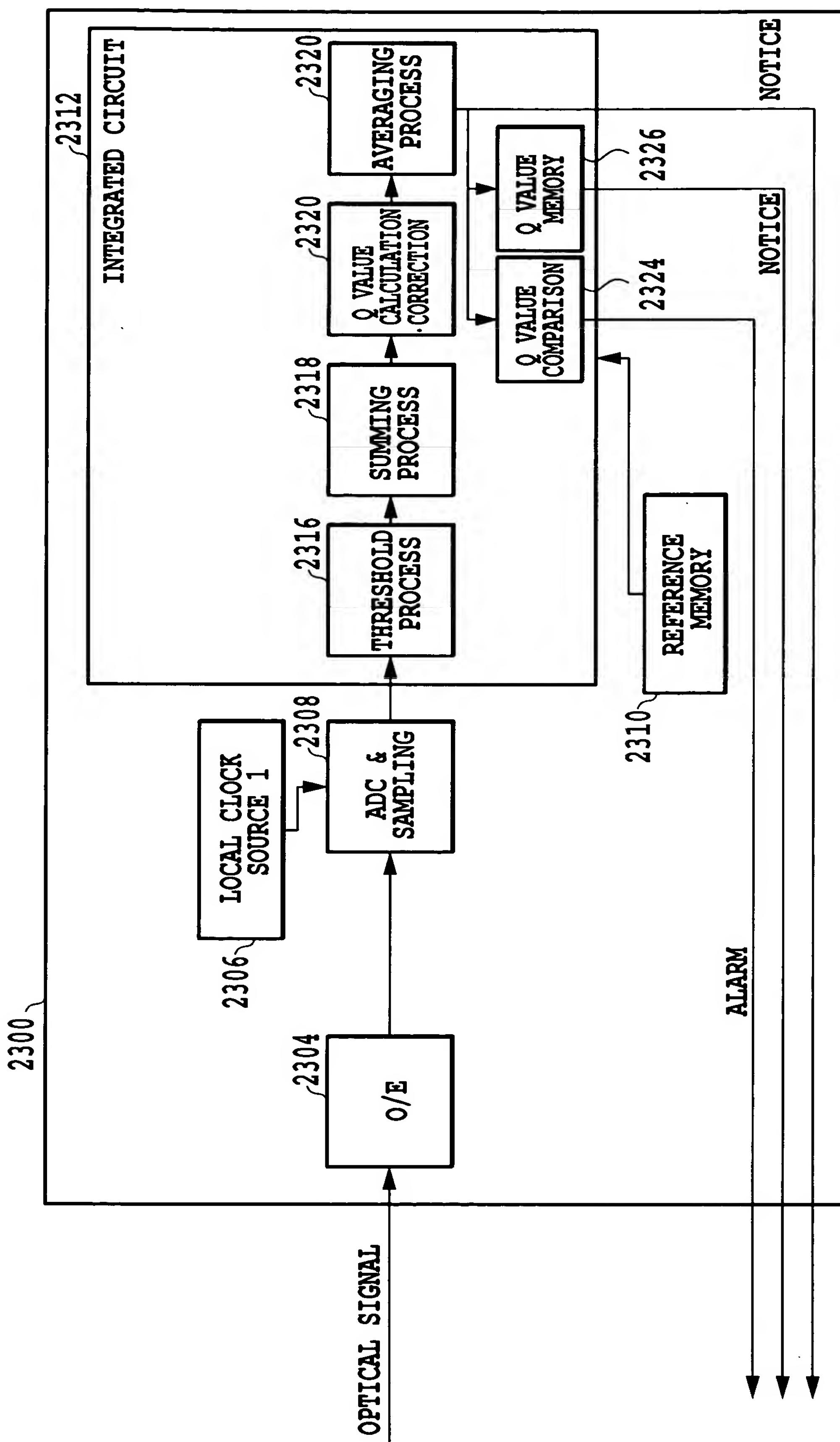


FIG.23

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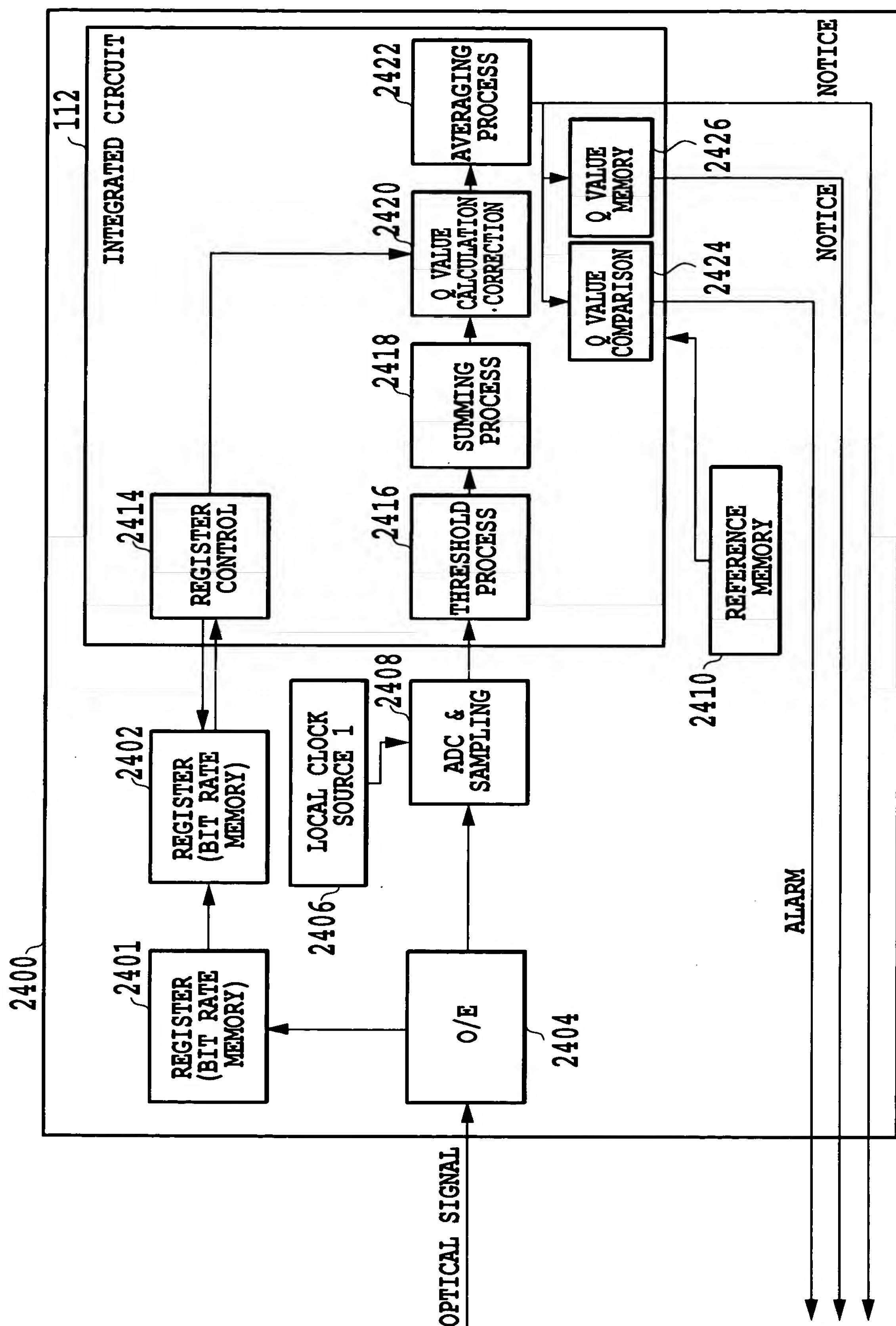


FIG.24

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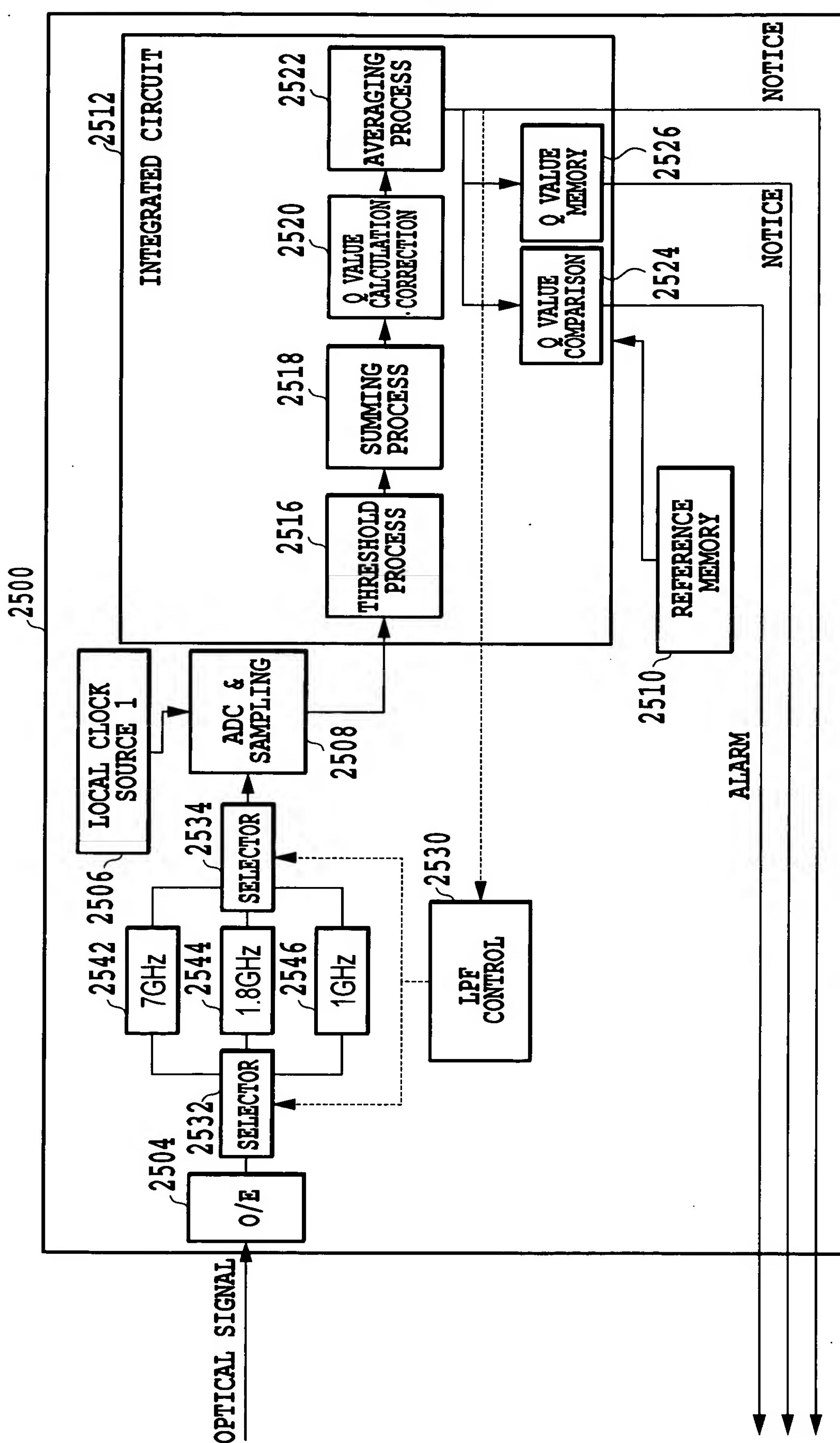


FIG. 25

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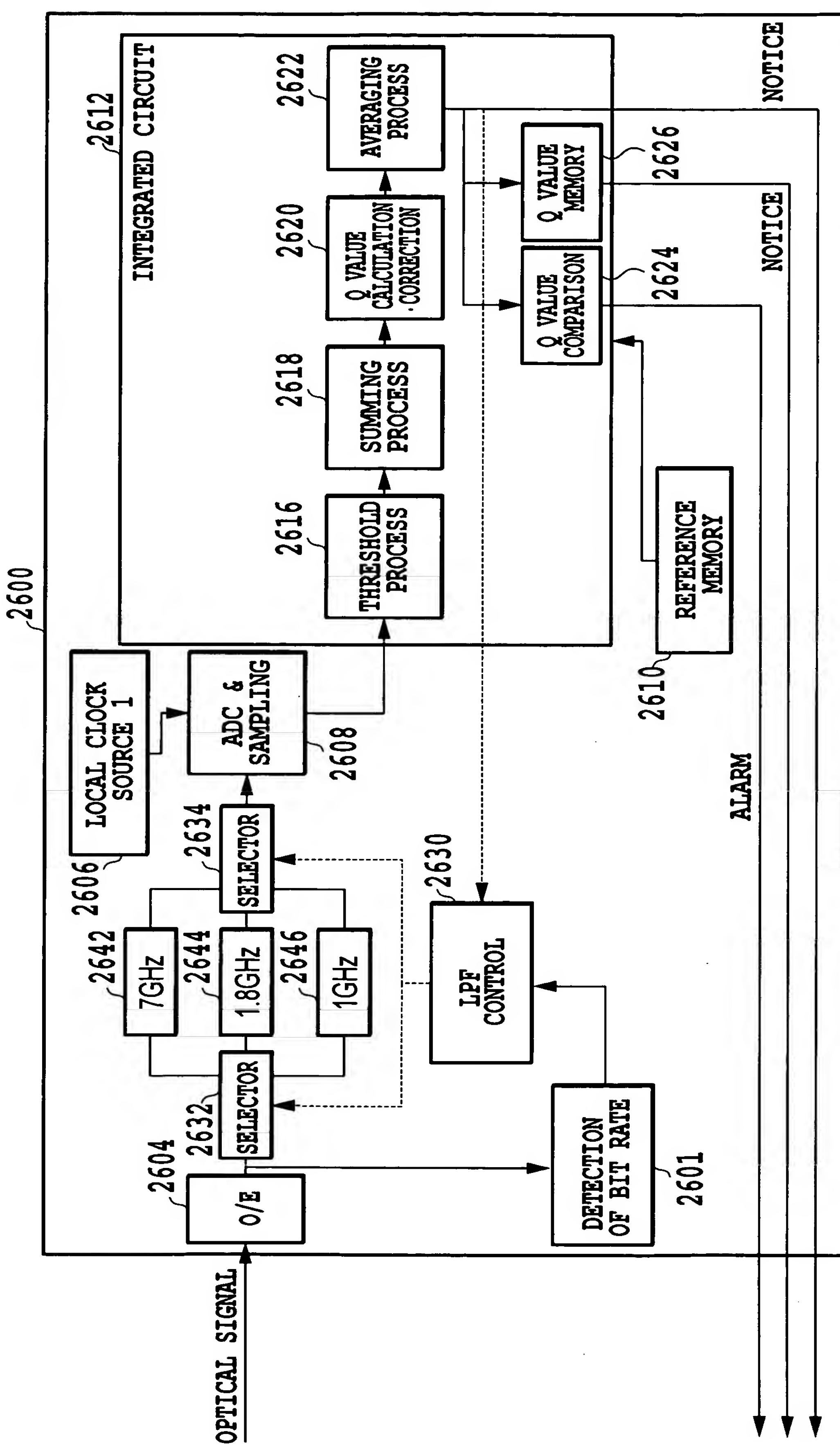


FIG.26

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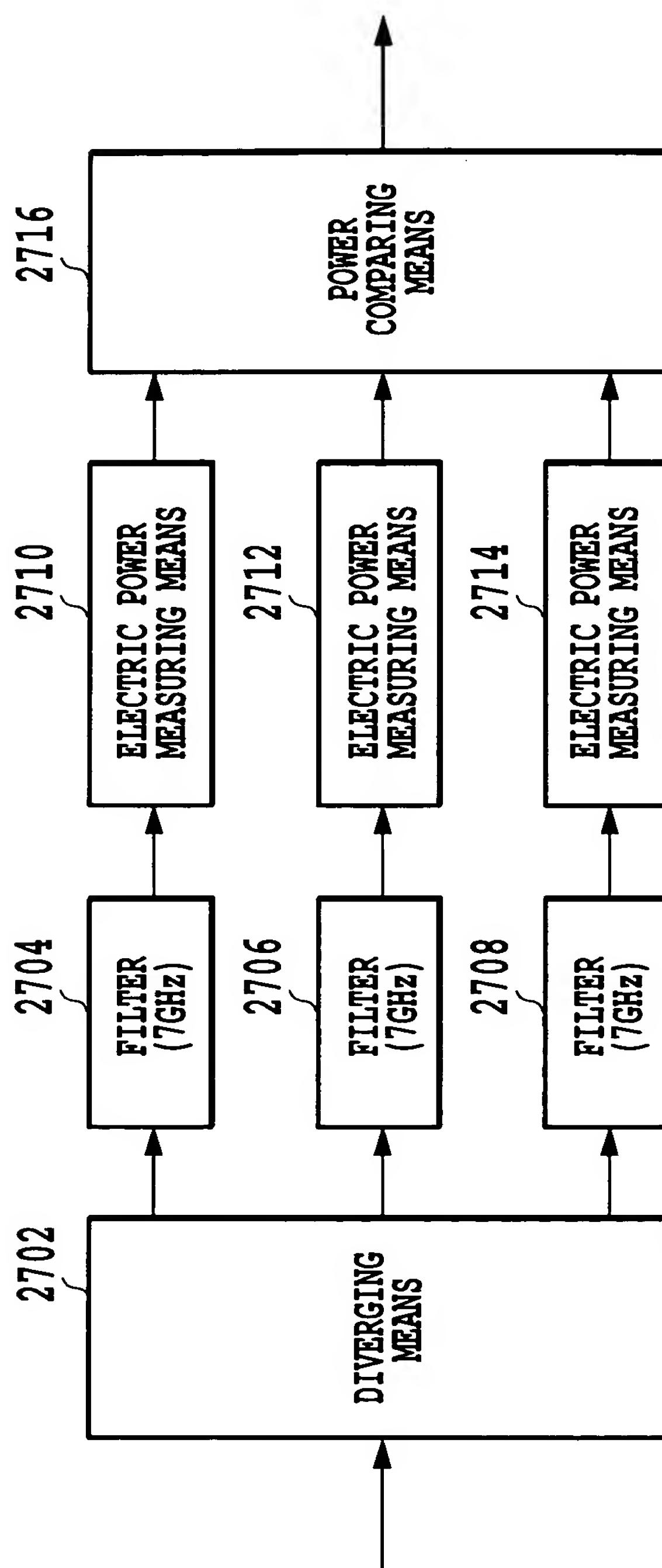


FIG. 27

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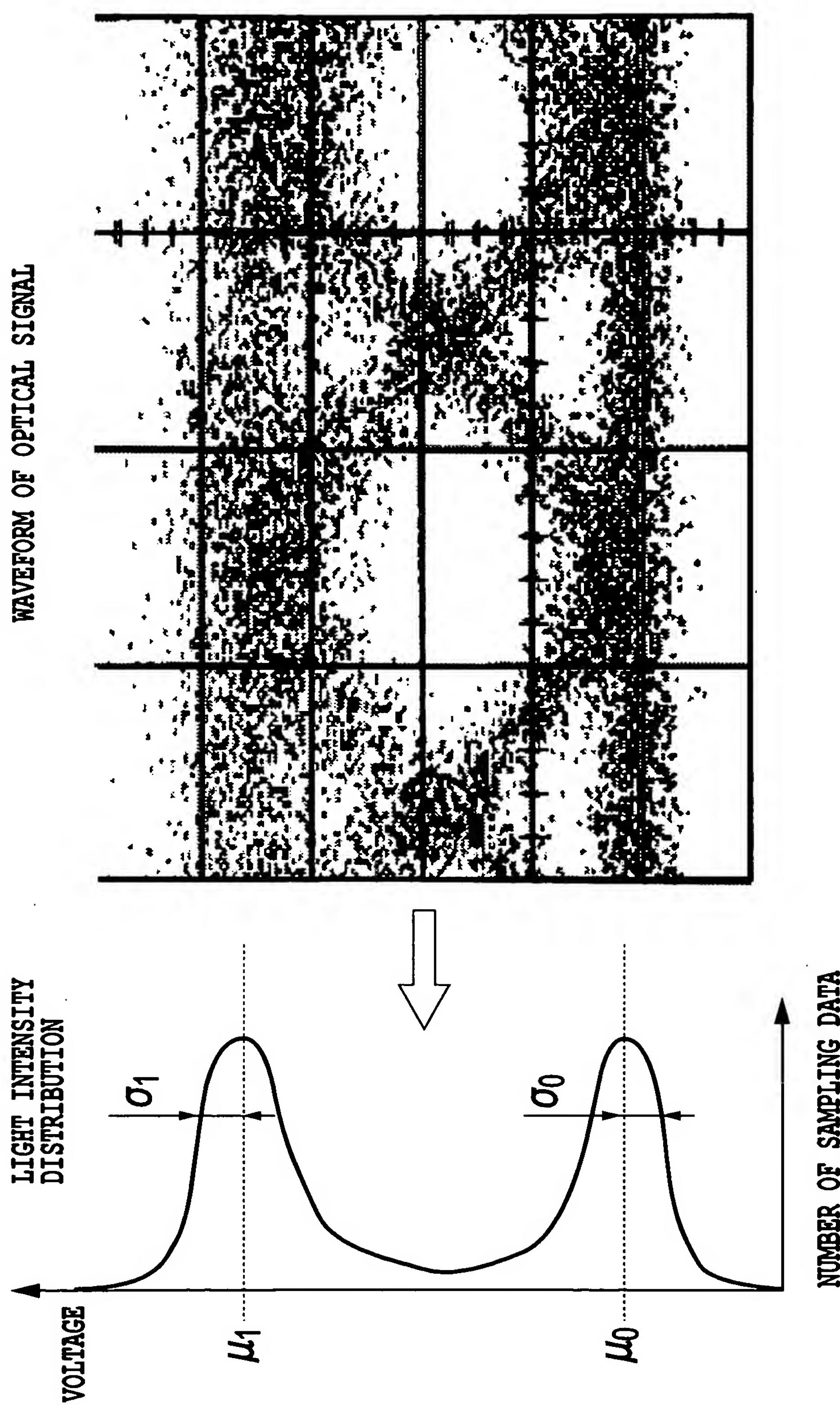


FIG.28

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FIG.29

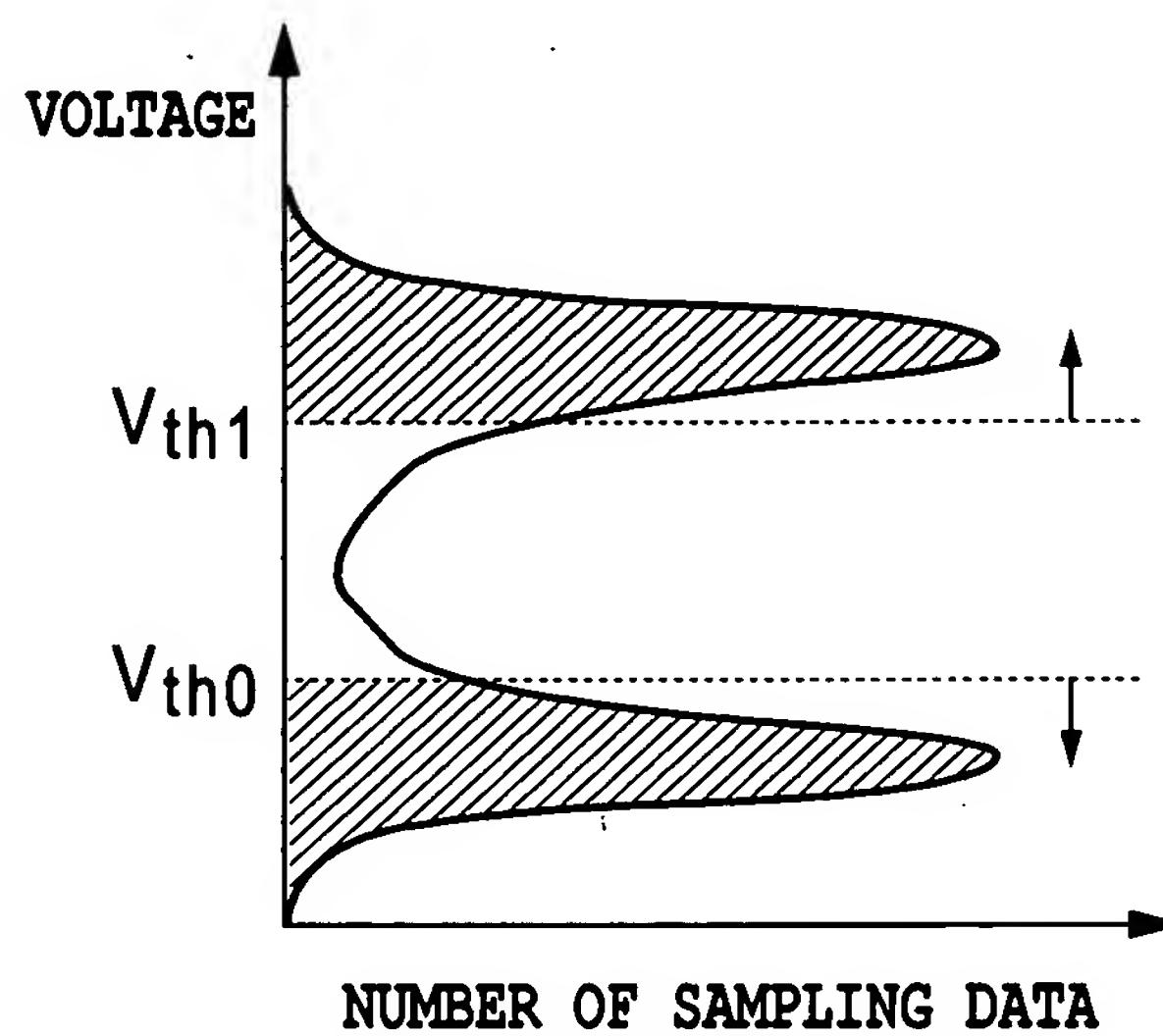
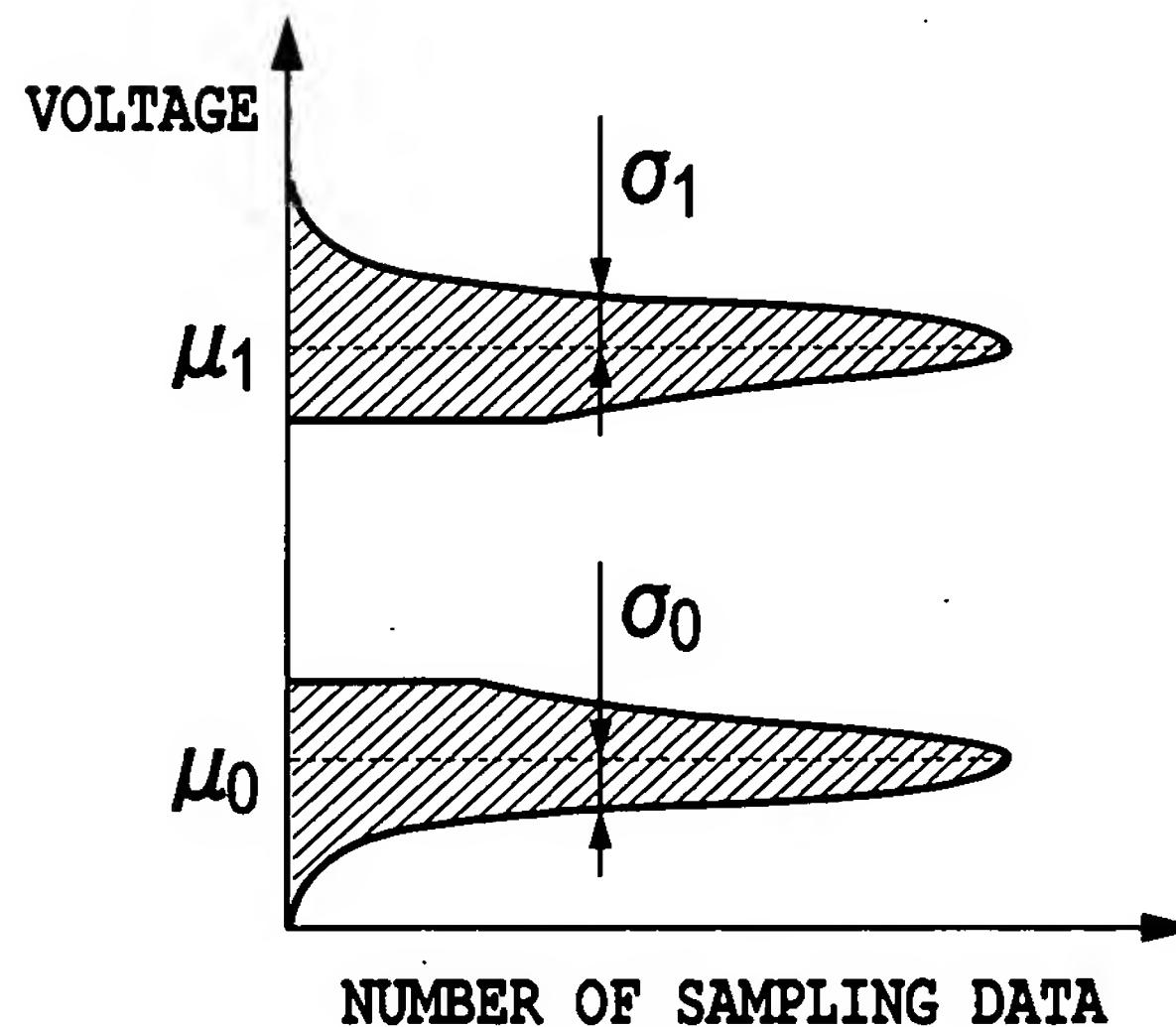


FIG.30



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FIG.31

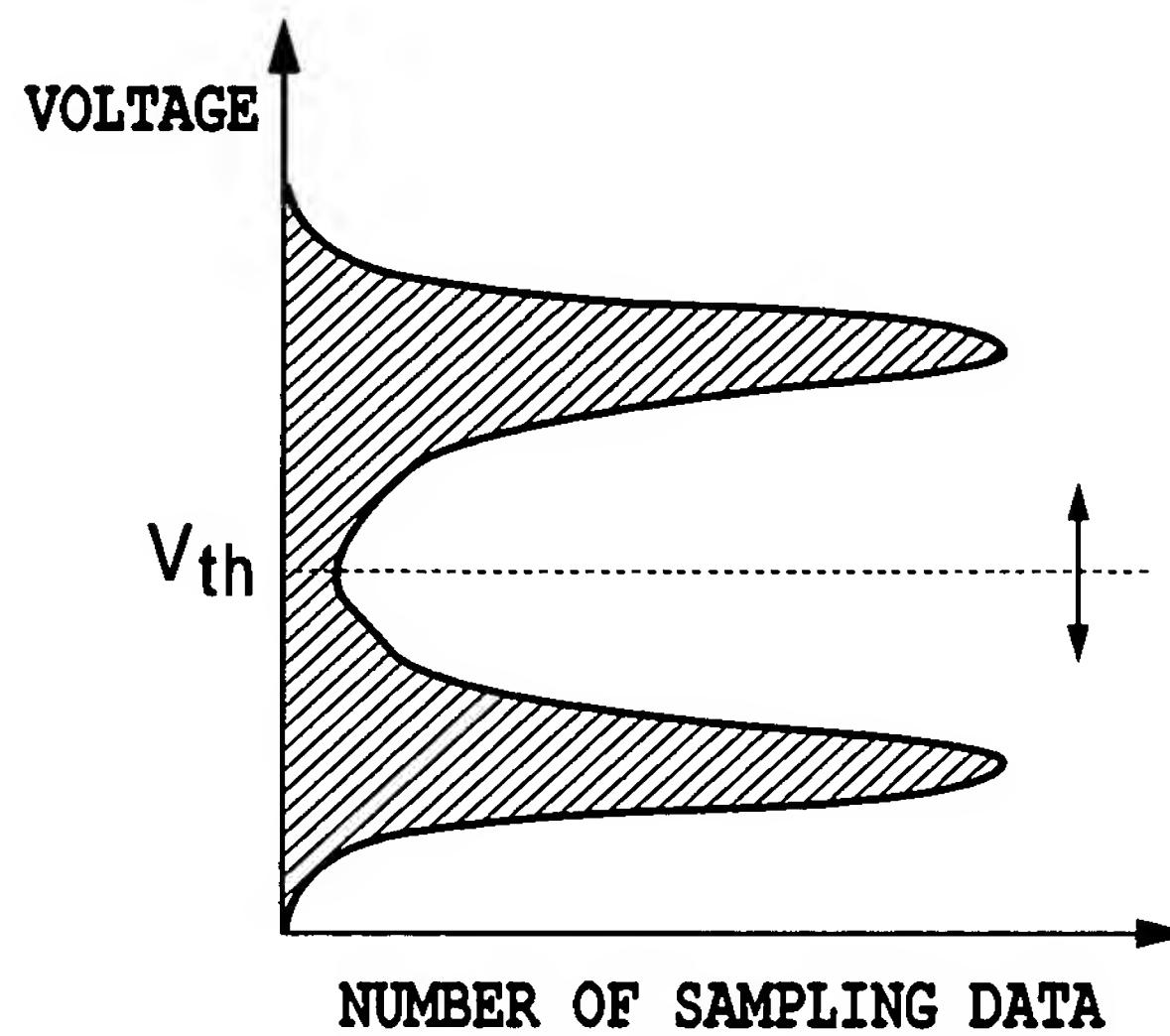
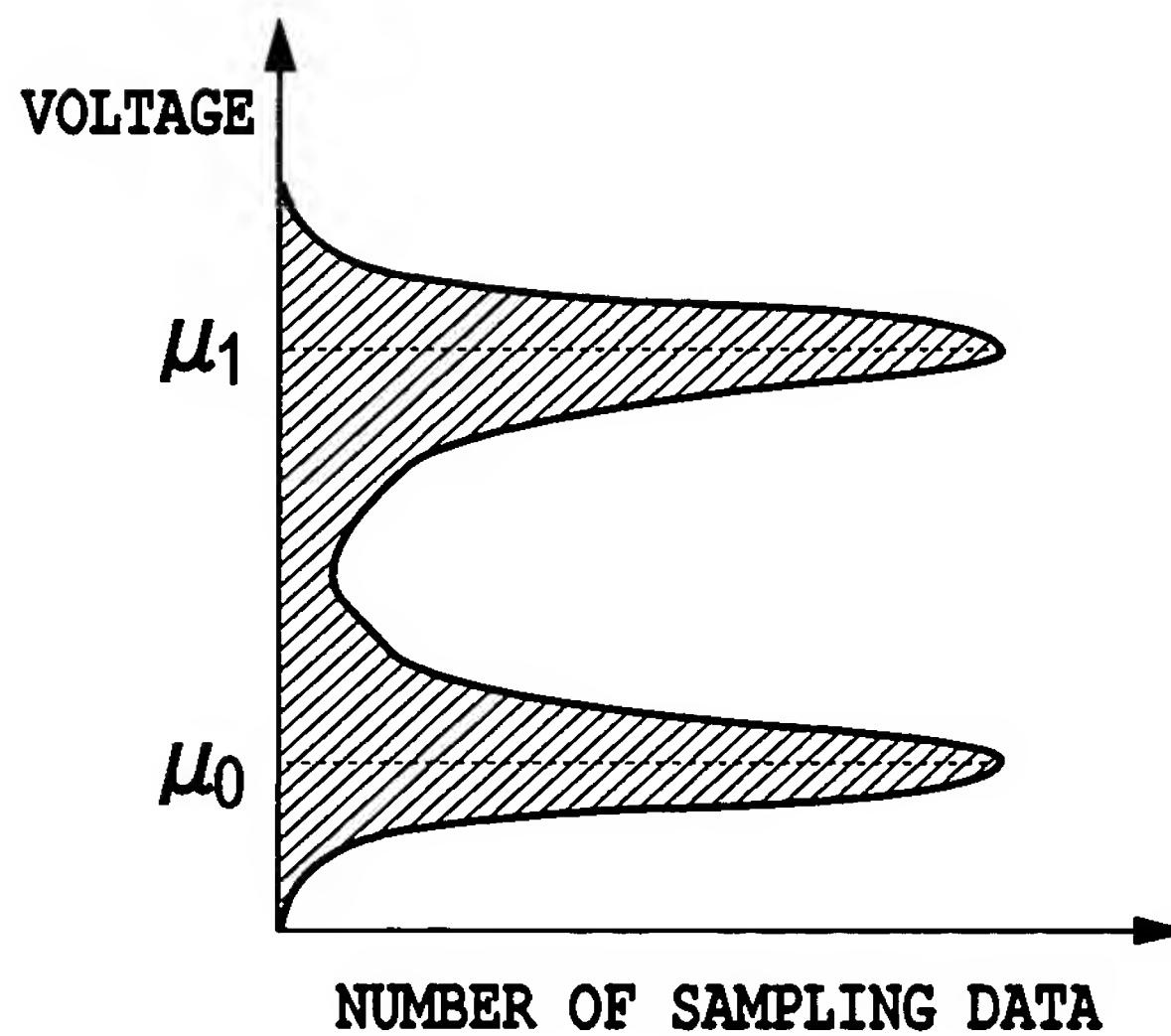


FIG.32



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FIG.33

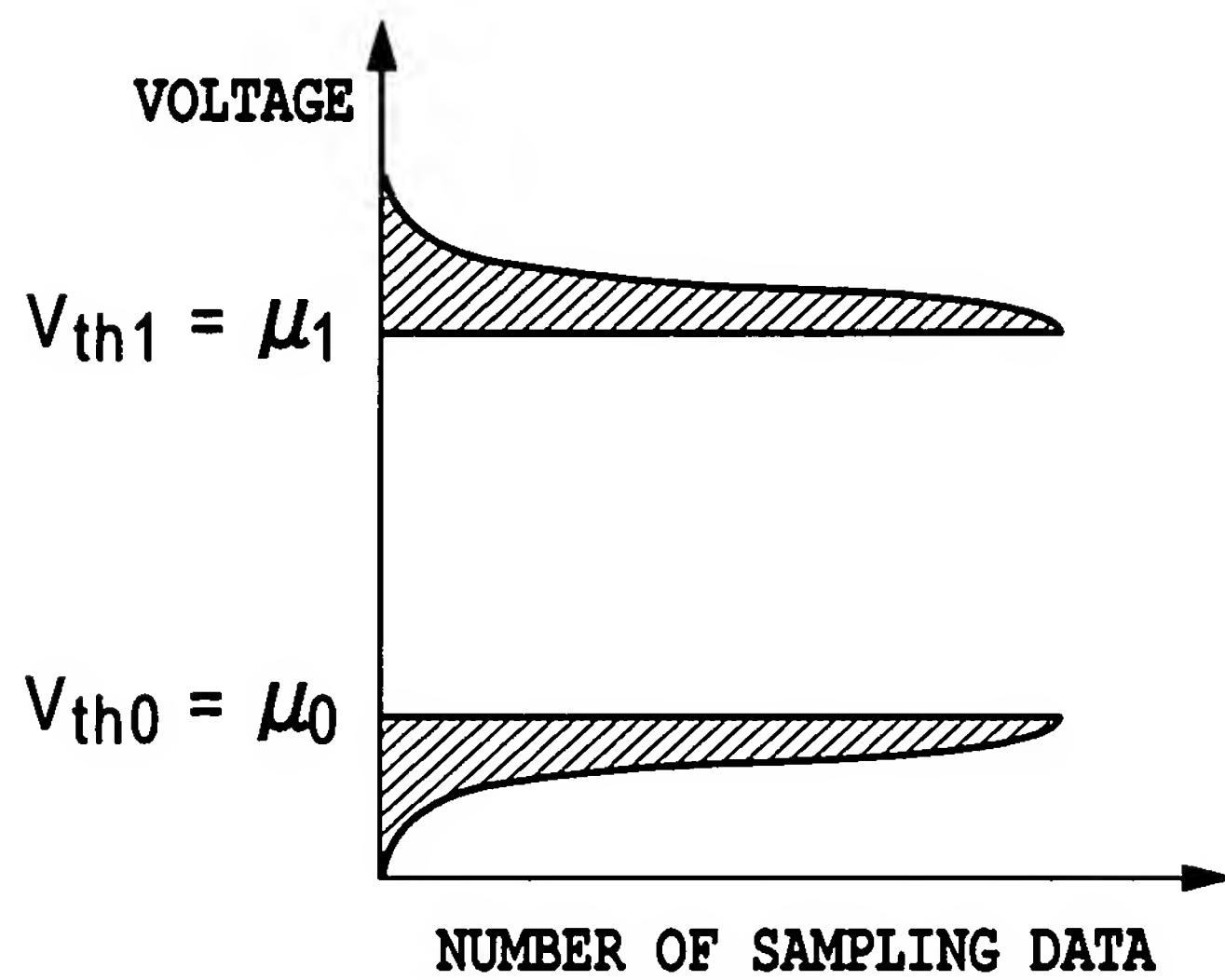
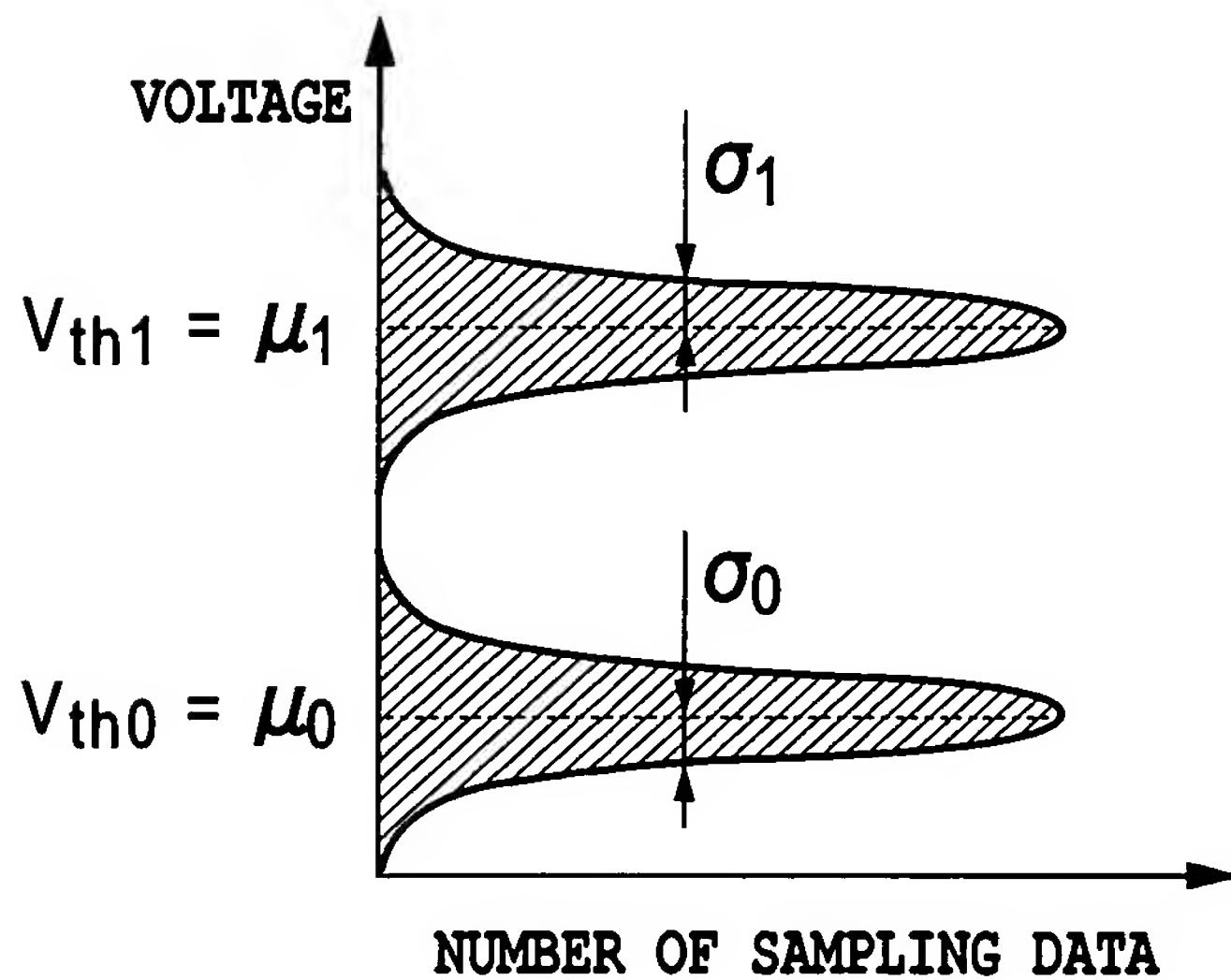


FIG.34



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FIG.35

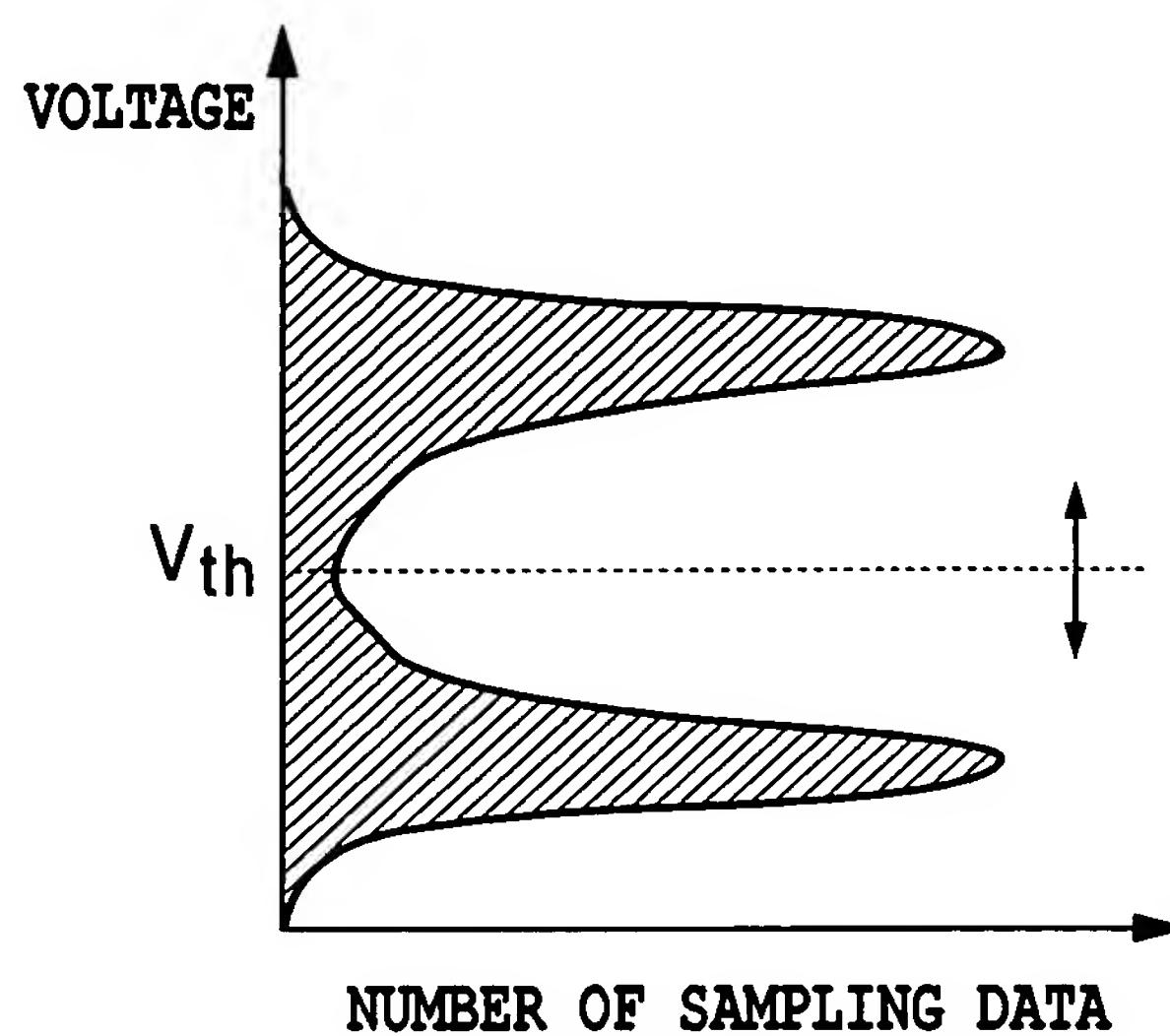
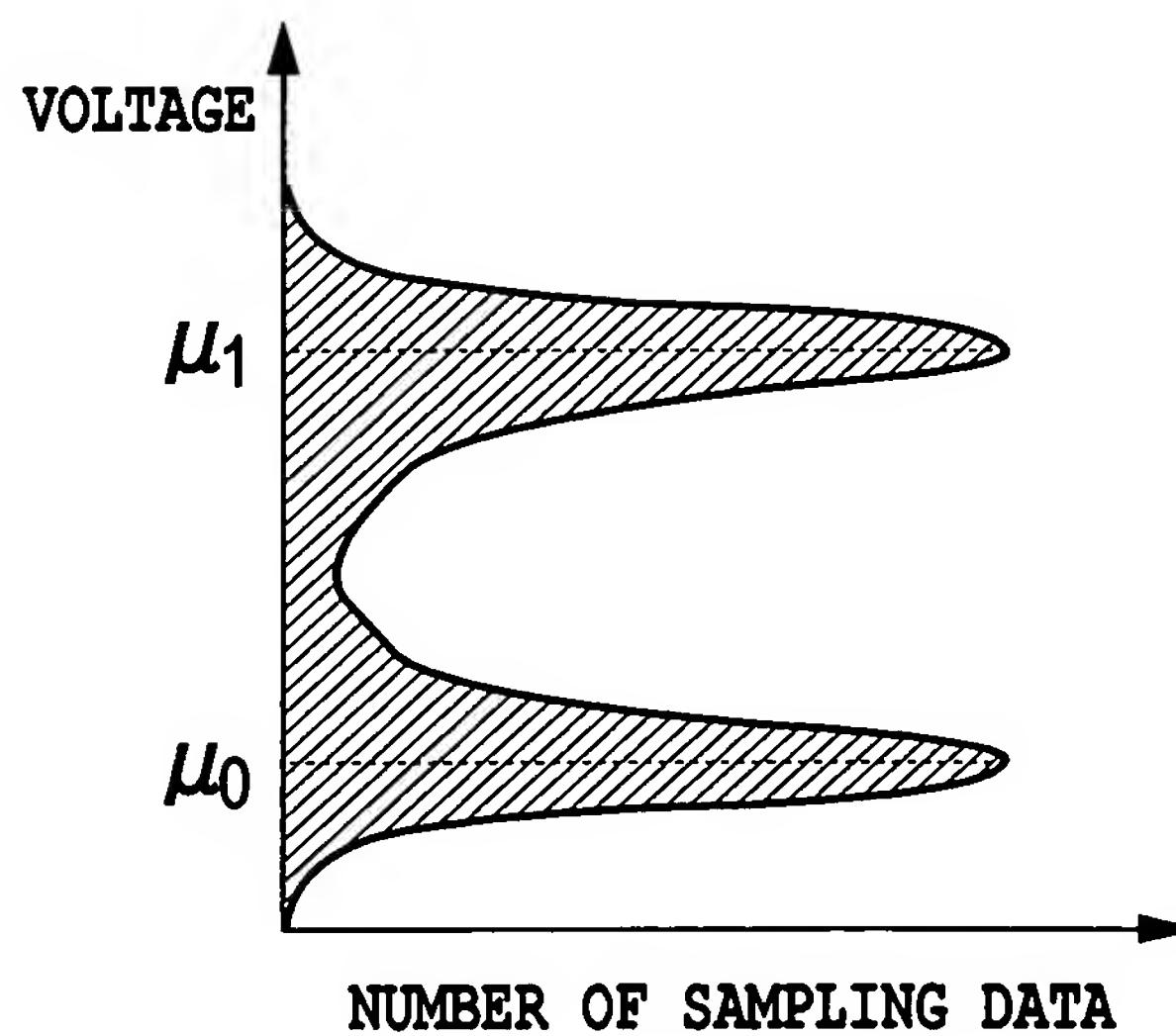


FIG.36



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FIG.37

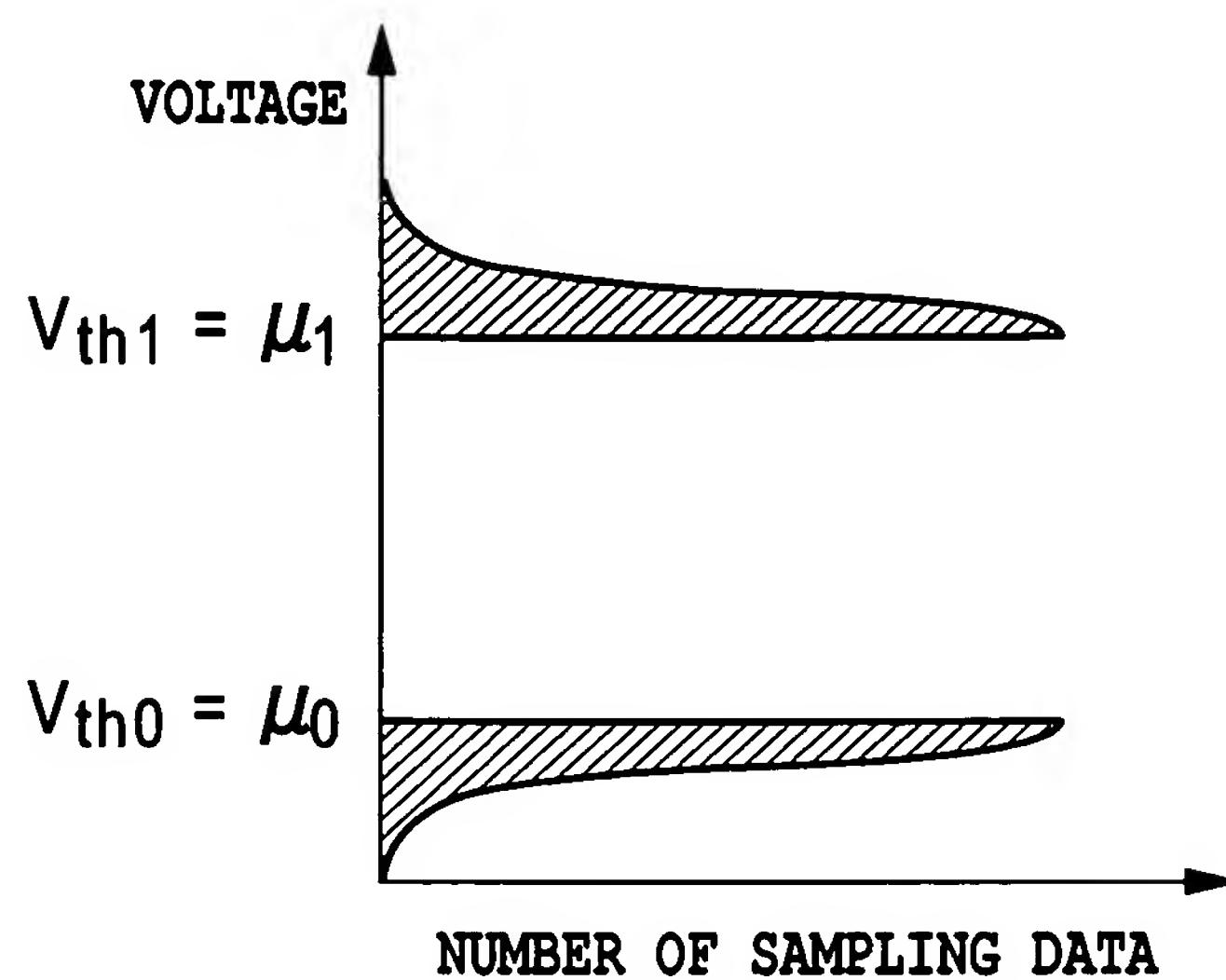


FIG.38

